

OCTAL SIMULTANEOUS-SAMPLING 24-BIT ANALOG-TO-DIGITAL CONVERTER

Check for Samples: ADS1278-HT

FEATURES

- Simultaneously Measure Eight Channels
- Up to 128-kSPS Data Rate
- AC Performance: 62-kHz Bandwidth 111-dB SNR (High-Resolution Mode) –108-dB THD
- DC Accuracy: 0.8-µV/°C Offset Drift 1.3-ppm/°C Gain Drift
- Selectable Operating Modes: High-Speed: 128 kSPS, 106 dB SNR High-Resolution: 52 kSPS, 111 dB SNR Low-Power: 52 kSPS, 31 mW/ch Low-Speed: 10 kSPS, 7 mW/ch
- Linear Phase Digital Filter
- SPI™ or Frame-Sync Serial Interface
- Low Sampling Aperture Error
- Modulator Output Option (digital filter bypass)
- Analog Supply: 5 V
- Digital Core: 1.8 V
- I/O Supply: 1.8 V to 3.3 V
- Currently Available in an HTQFP-64 PowerPAD[™] package, an 84-Pin HFQ Package and a KGD Chiptray Option

SUPPORTS EXTREME TEMPERATURE APPLICATIONS

- Controlled Baseline
- One Assembly/Test Site
- One Fabrication Site
- Available in Extreme (-55°C/210°C) Temperature Range ⁽¹⁾
- Extended Product Life Cycle
- Extended Product-Change Notification
- Product Traceability
- Texas Instruments High Temperature Products Utilize Highly Optimized Silicon (Die) Solutions With Dsign and Process Enhancements to Maximize Performance Over Extended Temperatures

APPLICATIONS

- Down-Hole Drilling
- High Temperature Environments
- Vibration/Modal Analysis
- Multi-Channel Data Acquisition
- Acoustics/Dynamic Strain Gauges
- Pressure Sensors

DESCRIPTION

Based on the single-channel ADS1271, the ADS1278 (octal) is a 24-bit, delta-sigma ($\Delta\Sigma$) analog-to-digital converter (ADC) with data rates up to 128 k samples per second (SPS), allowing simultaneous sampling of eight channels.

Traditionally, industrial delta-sigma ADCs offering good drift performance use digital filters with large passband droop. As a result, they have limited signal bandwidth and are mostly suited for dc measurements. High-resolution ADCs in audio applications offer larger usable bandwidths, but the offset and drift specifications are significantly weaker than respective industrial counterparts. The ADS1278 combines these types of converters, allowing highprecision industrial measurement with excellent dc and ac specifications.

The high-order, chopper-stabilized modulator achieves very low drift with low in-band noise. The onboard decimation filter suppresses modulator and signal out-of-band noise. These ADCs provide a usable signal bandwidth up to 90% of the Nyquist rate with less than 0.005 dB of ripple.

Four operating modes allow for optimization of speed, resolution, and power. All operations are controlled directly by pins; there are no registers to program. The device is fully specified over the extended industrial range (-55°C to 210°C) and is available in an HTQFP-64 PowerPAD package (-55°C to 175°C), an 84-pin HFQ package and a KGD chiptray option.

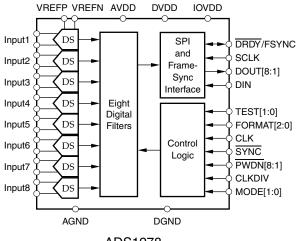
(1) Custom temperature ranges available

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet. SPI is a trademark of Motorola, Inc.

All other trademarks are the property of their respective owners.



SBAS447E - MARCH 2009-REVISED APRIL 2013



ADS1278



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

Table 1. ORDERING INFORMATION⁽¹⁾

T _A	PACKAGE	ORDERABLE PART NUMBER
–55°C to 175°C	PAP	ADS1278HPAP
	HFQ	ADS1278SHFQ
–55°C to 210°C	HKP	ADS1278SHKP
	CHIPTRAY (bare die)	ADS1278SKGDA

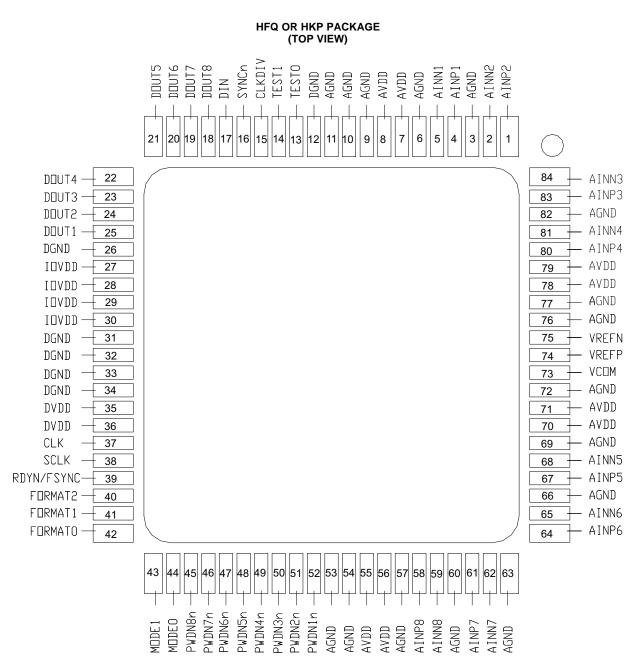
(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI Web site at www.ti.com.

ADS1278-HT

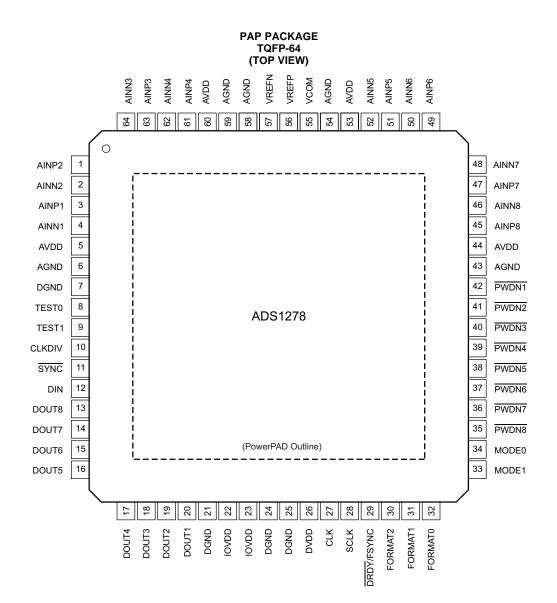
SBAS447E – MARCH 2009–REVISED APRIL 2013

www.ti.com









4



ADS1278-HT

www.ti.com

SBAS447E - MARCH 2009-REVISED APRIL 2013

Table 2. HFQ or HKP PIN DESCRIPTIONS

PIN NAME	FUNCTION	DESCRIPTION
AGND	Analog ground	Analog ground; connect to DGND using a single plane.
AINP1	Analog input	
AINP2	Analog input	
AINP3	Analog input	
AINP4	Analog input	
AINP5	Analog input	AINP[8:1] Positive analog input, channels 8 through 1.
AINP6	Analog input	
AINP7	Analog input	
AINP8	Analog input	
AINN1	Analog input	
AINN2	Analog input	
AINN3	Analog input	
AINN4	Analog input	
AINN5	Analog input	AINN[8:1] Negative analog input, channels 8 through 1.
AINN6	Analog input	
AINN7	Analog input	
AINN8	Analog input	
AVDD	Analog power supply	Analog power supply (4.75V to 5.25V).
VCOM	Analog output	AVDD/2 Unbuffered voltage output.
VREFN	Analog input	Negative reference input.
VREFP	Analog input	Positive reference input.
CLK	Digital input	Master clock input.
CLKDIV	Digital input	CLK input divider control: 1 = 32.768MHz (High-Speed mode only) / 27MHz 0 = 13.5MHz (low-power) / 5.4MHz (low-speed)
DGND	Digital ground	Digital ground power supply.
DIN	Digital input	Daisy-chain data input.
DOUT1	Digital output	DOUT1 is TDM data output (TDM mode).
DOUT2	Digital output	
DOUT3	Digital output	
DOUT4	Digital output	
DOUT5	Digital output	DOUT[8:1] Data output for channels 8 through 1.
DOUT6	Digital output	
DOUT7	Digital output	
DOUT8	Digital output	
DRDY/ FSYNC	Digital input/output	Frame-Sync protocol: frame clock input; SPI protocol: data ready output.
DVDD	Digital power supply	Digital core power supply (+1.65V to +1.95V).
FORMAT0	Digital input	
FORMAT1	Digital input	FORMAT[2:0] Selects Frame-Sync/SPI protocol, TDM/discrete data outputs, fixed/dynamic position TDM data, and modulator mode/normal operating mode.
FORMAT2	Digital input	
IOVDD	Digital power supply	I/O power supply (+1.65V to +3.6V).
MODE0	Digital input	MODE[1:0] Selects High-Speed, High-Resolution, Low-Power, or Low-Speed mode operation.
MODE1	Digital input	work in a selects migh-speed, migh-kesolution, Low-Power, or Low-Speed mode operation.

PIN

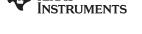
Table 2. HFQ or HKP PIN DESCRIPTIONS (continued)

PIN NAME	FUNCTION	DESCRIPTION						
PWDN1	Digital input							
PWDN2	Digital input							
PWDN3	Digital input							
PWDN4	Digital input	PWDN[8:1] Power-down control for channels 8 through 1.						
PWDN5	Digital input							
PWDN6	Digital input							
PWDN7	Digital input							
PWDN8	Digital input							
SCLK	Digital input/output	Serial clock input, Modulator clo	Serial clock input, Modulator clock output.					
SYNC	Digital input	Synchronize input (all channels)	Synchronize input (all channels).					
TEST0	Digital input	TEST[1:0] Test mode select:	00 = Normal operation	01 = Do not use				
TEST1	Digital input		11 = Test mode	10 = Do not use				

FIN					
NAME	NO.	FUNCTION	DESCRIPTION		
AGND	6, 43, 54, 58, 59	Analog ground	Analog ground; connect to DGND using a single plane.		
AINP1	3	Analog input			
AINP2	1	Analog input			
AINP3	63	Analog input			
AINP4	61	Analog input	AINP[8:1] Positive analog input, channels 8 through 1.		
AINP5	51	Analog input			
AINP6	49	Analog input			
AINP7	47	Analog input			
AINP8	45	Analog input			
AINN1	4	Analog input			
AINN2	2	Analog input			
AINN3	64	Analog input			
AINN4	62	Analog input	AINN[8:1] Negative analog input, channels 8 through 1.		
AINN5	52	Analog input			
AINN6	50	Analog input			
AINN7	48	Analog input			
AINN8	46	Analog input			
AVDD	5, 44, 53, 60	Analog power supply	Analog power supply (4.75V to 5.25V).		
VCOM	55	Analog output	AVDD/2 Unbuffered voltage output.		
VREFN	57	Analog input	Negative reference input.		
VREFP	56	Analog input	Positive reference input.		
CLK	27	Digital input	Master clock input (f _{CLK}).		
CLKDIV	10	Digital input	CLK input divider control: 1 = 37MHz (High-Speed mode)/otherwise 27MHz 0 = 13.5MHz (low-power)/5.4MHz (low-speed)		
DGND	7, 21, 24, 25	Digital ground	Digital ground power supply.		
DIN	12	Digital input	Daisy-chain data input.		
DOUT1	20	Digital output	DOUT1 is TDM data output (TDM mode).		
DOUT2	19	Digital output			
DOUT3	18	Digital output			
DOUT4	17	Digital output	DOUT[8:1] Data output for channels 8 through 1.		

Table 3. PAP PIN DESCRIPTIONS

www.ti.com



EXAS



ADS1278-HT

www.ti.com

SBAS447E - MARCH 2009-REVISED APRIL 2013

I	PIN					
NAME	NO.	FUNCTION	DESCRIPTION			
DOUT5	16	Digital output				
DOUT6	15	Digital output				
DOUT7	14	Digital output				
DOUT8	13	Digital output				
DRDY/ FSYNC	29	Digital input/output	Frame-Sync protocol: frame clock input; SPI protocol: data ready output.			
DVDD	26	Digital power supply	Digital core power supply.			
FORMAT0	32	Digital input				
FORMAT1	31	Digital input	FORMAT[2:0] Selects Frame-Sync/SPI protocol, TDM/discrete data outputs, fixed/dynamic position TDM data, and modulator mode/normal operating mode.			
FORMAT2	30	Digital input				
IOVDD	22, 23	Digital power supply	I/O power supply (+1.65V to +3.6V).			
MODE0	34	Digital input	MODE[1:0] Selects High-Speed, High-Resolution, Low-Power, or Low-Speed			
MODE1	33	Digital input	mode operation.			
PWDN1	42	Digital input				
PWDN2	41	Digital input				
PWDN3	40	Digital input				
PWDN4	39	Digital input	PWDN[8:1] Power-down control for channels 8 through 1.			
PWDN5	38	Digital input				
PWDN6	37	Digital input				
PWDN7	36	Digital input				
PWDN8	35	Digital input				
SCLK	28	Digital input/output	Serial clock input, Modulator clock output.			
SYNC	11	Digital input	Synchronize input (all channels).			
TEST0	8	Digital input	TEST[1:0] Test mode select: 00 = Normal operation 01 = Do not use			
TEST1	9	Digital input	11 = Test mode 10 = Do not use			

ADS1278-HT

SBAS447E - MARCH 2009-REVISED APRIL 2013

EXAS

BARE DIE INFORMATION

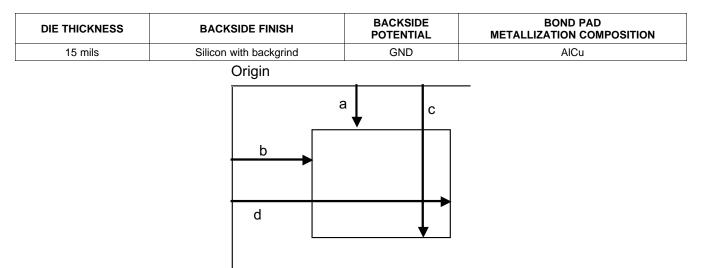


Table 4. Bond Pad Coordinates in Microns - Rev A⁽¹⁾

DISCRIPTION	PAD NUMBER	а	b	С	d
Do not connect	1	5.00	4455.65	70.00	4520.65
AINP2	2	5.00	4355.65	70.00	4420.65
AINN2	3	5.00	4255.65	70.00	4320.65
Do not connect	4	5.00	4155.65	70.00	4220.65
Do not connect	5	5.00	4038.30	70.00	4103.30
AINP1	6	5.00	3938.30	70.00	4003.30
AINN1	7	5.00	3838.30	70.00	3903.30
Do not connect	8	5.00	3738.30	70.00	3803.30
AVDD	9	5.00	3373.30	70.00	3678.30
AGND	10	5.00	3033.30	70.00	3338.30
Do not connect	11	5.00	2853.30	70.00	2998.30
DGND	12	5.00	1911.65	70.00	1976.65
TEST0	13	5.00	1760.45	70.00	1825.45
Do not connect	14	5.00	1648.95	70.00	1713.95
TEST1	15	5.00	1536.60	70.00	1601.60
CLKDIV	16	5.00	1385.40	70.00	1450.40
SYNC	17	5.00	1234.20	70.00	1299.20
DIN	18	5.00	1083.00	70.00	1148.00
DOUT8	19	5.00	780.60	70.00	845.60
DOUT7	20	5.00	629.40	70.00	694.40
DOUT6	21	5.00	478.20	70.00	543.20
DOUT5	22	5.00	275.80	70.00	340.80
DOUT4	23	275.80	5.00	340.80	70.00
DOUT3	24	745.40	5.00	810.40	70.00
DOUT2	25	1099.30	5.00	1164.30	70.00
DOUT1	26	1250.50	5.00	1315.50	70.00
DGND	27	1525.25	5.00	1590.25	70.00
IOVDD	28	1691.00	5.00	1756.00	70.00
IOVDD	29	1842.20	5.00	1907.20	70.00

(1) For signal descriptions see the Pin Descriptions table.



SBAS447E - MARCH 2009-REVISED APRIL 2013

Table 4. Bond Pad Coordinates in Microns - Rev A⁽¹⁾ (continued)

DISCRIPTION	PAD NUMBER	а	b	С	d
IOVDD	30	2068.10	5.00	2133.10	70.00
IOVDD	31	2292.45	5.00	2597.45	70.00
DGND	32	2632.45	5.00	2697.45	70.00
DGND	33	2732.45	5.00	3277.45	70.00
DGND	34	3312.45	5.00	3457.45	70.00
DVDD	35	3492.45	5.00	3797.45	70.00
CLK	36	3869.40	5.00	3934.40	70.00
SCLK	37	4201.90	5.00	4266.90	70.00
DRDY/FSYNC	38	4423.90	5.00	4488.90	70.00
FORMAT2	39	4866.90	5.00	4931.90	70.00
FORMAT1	40	5199.40	5.00	5264.40	70.00
FORMATO	41	5669.00	5.00	5734.00	70.00
MODE1	42	5939.80	275.80	6004.80	340.80
MODE0	43	5939.80	478.20	6004.80	543.20
PWDN8	43	5939.80	629.40	6004.80	694.40
PWDN8	44	5939.80	780.60	6004.80	845.60
PWDN6	46	5939.80	1083.00	6004.80	1148.00
PWDN5	40	5939.80	1234.20	6004.80	1299.20
PWDN3	47	5939.80	1385.40	6004.80	1299.20
PWDN4 PWDN3	48	5939.80	1536.60	6004.80	1601.60
Do not connect	50	5939.80	1648.95	6004.80	1713.95
PWDN2	50	5939.80	1760.45	6004.80	1825.45
PWDN2 PWDN1	52				1976.65
		5939.80	1911.65	6004.80	
Do not connect AGND	53	5939.80 5939.80	2853.30 3033.30	6004.80	2998.30 3338.30
AGND	55	5939.80	3373.30	6004.80 6004.80	3678.30
	55				3803.30
Do not connect		5939.80	3738.30	6004.80	
AINP8	57	5939.80	3838.30	6004.80	3903.30
AINN8	58	5939.80	3938.30	6004.80	4003.30
Do not connect	59	5939.80	4038.30	6004.80	4103.30
Do not connect	60	5939.80	4155.65	6004.80	4220.65
AINP7	61	5939.80	4255.65	6004.80	4320.65
AINN7	62	5939.80	4355.65	6004.80	4420.65
Do not connect	63	5939.80	4455.65	6004.80	4520.65
Do not connect	64	5664.20	4726.45	5729.20	4791.45
AINP6	65	5564.20	4726.45	5629.20	4791.45
AINN6	66	5464.20	4726.45	5529.20	4791.45
Do not connect	67	5364.20	4726.45	5429.20	4791.45
Do not connect	68	4925.95	4726.45	4990.95	4791.45
AINP5	69	4825.95	4726.45	4890.95	4791.45
AINN5	70	4725.95	4726.45	4790.95	4791.45
Do not connect	71	4625.95	4726.45	4690.95	4791.45
AVDD	72	4337.40	4726.45	4402.40	4791.45
AVDD	73	4077.40	4726.45	4302.40	4791.45
AGND	74	3817.40	4726.45	4042.40	4791.45
Do not connect	75	3717.40	4726.45	3782.40	4791.45
VCOM	76	3617.40	4726.45	3682.40	4791.45

Copyright © 2009–2013, Texas Instruments Incorporated



www.ti.com

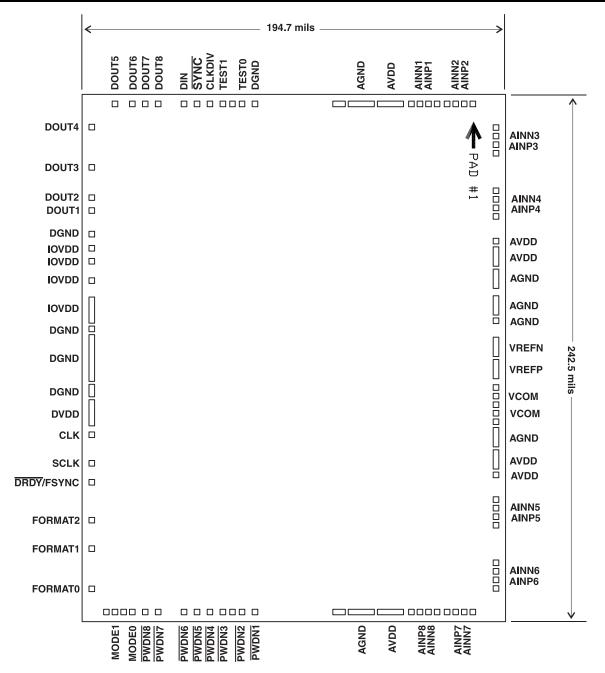
Table 4. Bond Pad Coordinates in Microns - Rev	A ⁽¹⁾ (continued)
--	------------------------------

DISCRIPTION	PAD NUMBER	а	b	C	d		
Do not connect	77	3517.40	4726.45	3582.40	4791.45		
VCOM	78	3417.40	4726.45	3482.40	4791.45		
Do not connect	79	3317.40	4726.45	3382.40	4791.45		
VREFP	80	3022.40	4726.45	3247.40	4791.45		
VREFN	81	2762.40	4726.45	2987.40	4791.45		
AGND	82	2537.40	4726.45	2602.40	4791.45		
AGND	83	2277.40	4726.45	2502.40	4791.45		
AGND	84	1967.40	4726.45	2192.40	4791.45		
AVDD	85	1707.40	4726.45	1932.40	4791.45		
AVDD	86	1607.40	4726.45	1672.40	4791.45		
Do not connect	87	1318.85	4726.45	1383.85	4791.45		
AINP4	88	1218.85	4726.45	1283.85	4791.45		
AINN4	89	1118.85	4726.45	1183.85	4791.45		
Do not connect	90	1018.85	4726.45	1083.85	4791.45		
Do not connect	91	580.60	4726.45	645.60	4791.45		
AINP3	92	480.60	4726.45	545.60	4791.45		
AINN3	93	380.60	4726.45	445.60	4791.45		
Do not connect	94	280.60	4726.45	345.60	4791.45		
Do not connect	95	5939.80	377.00	6004.80	442.00		
Do not connect	96	5939.80	175.80	6004.80	240.80		

EXAS

INSTRUMENTS

SBAS447E - MARCH 2009-REVISED APRIL 2013



ABSOLUTE MAXIMUM RATINGS

Over operating free-air temperature range, unless otherwise noted⁽¹⁾

			UNIT
AVDD to AGND		-0.3 to 6.0	V
DVDD, IOVDD to DGND		-0.3 to 3.6	V
AGND to DGND		-0.3 to 0.3	V
	Momentary	100	mA
Input current	Continuous	10	mA
Analog input to AGND		-0.3 to AVDD + 0.3	V
Digital input or output to DGND		-0.3 to DVDD + 0.3	V
Junction temperature range	HFQ and HKP Packages	-55 to 217	°C
	D Package	-55 to 175	

(1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not implied.

THERMAL INFORMATION

		ADS		
	THERMAL METRIC ⁽¹⁾	PAP	HFQ/HKP	UNITS
		64 PINS	84 PINS	
θ_{JA}	Junction-to-ambient thermal resistance ⁽²⁾	33.1	21.813	
θ _{JCtop}	Junction-to-case (top) thermal resistance ⁽³⁾	6.2	0.849	
θ_{JB}	Junction-to-board thermal resistance ⁽⁴⁾	7.9	N/A	0 0 AA/
Ψ _{JT}	Junction-to-top characterization parameter ⁽⁵⁾	0.2	N/A	°C/W
Ψ_{JB}	Junction-to-board characterization parameter ⁽⁶⁾	7.8	N/A	
θ_{JCbot}	Junction-to-case (bottom) thermal resistance ⁽⁷⁾	0.2	N/A	

For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, SPRA953.
 The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, high-K board, as

2) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, high-K board, as specified in JESD51-7, in an environment described in JESD51-2a.

(3) The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDECstandard test exists, but a close description can be found in the ANSI SEMI standard G30-88.

(4) The junction-to-board thermal resistance is obtained by simulating in an environment with a ring cold plate fixture to control the PCB temperature, as described in JESD51-8.

(5) The junction-to-top characterization parameter, ψ_{JT} , estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining θ_{JA} , using a procedure described in JESD51-2a (sections 6 and 7).

(6) The junction-to-board characterization parameter, ψ_{JB} , estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining θ_{JA} , using a procedure described in JESD51-2a (sections 6 and 7).

(7) The junction-to-case (bottom) thermal resistance is obtained by simulating a cold plate test on the exposed (power) pad. No specific JEDEC standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.



www.ti.com

ELECTRICAL CHARACTERISTICS

All specifications at $T_A = T_J = -55^{\circ}$ C to 210°C, AVDD = 5 V, DVDD = 1.8 V, IOVDD = 3.3 V, $f_{CLK} = 27$ MHz, VREFP = 2.5 V, VREFN = 0 V, and all channels active, unless otherwise noted.

			T _A = -	-55°C to 12	5°C	T _A	= 210°C ⁽¹⁾		
PA	RAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	MIN	TYP	MAX	UNIT
Analog Inputs									
Full-scale input vo	Itage (FSR ⁽²⁾)	$V_{IN} = (AINP - AINN)$		$\pm V_{REF}$			$\pm V_{REF}$		V
Absolute input volt	age	AINP or AINN to AGND	AGND – 0.1		AVDD + 0.1	AGND – 0.1		AVDD + 0.1	V
Common-mode in	put voltage (V _{CM})	$V_{CM} = (AINP + AINN)/2$		2.5			2.5		V
	High-Speed mode			14			14		kΩ
Differential input	High-Resolution mode			14			14		kΩ
impedance	Low-Power mode			28			28		kΩ
	Low-Speed mode			140			140		kΩ
DC Performance			1						
Resolution		No missing codes	24						Bits
		f _{CLK} = 32.768MHz ⁽³⁾		128,000			128,000		SPS
Data rate (f _{DATA})	High-Speed mode	f _{CLK} = 27MHz		105,469			105,469		SPS ⁽⁴⁾
	High-Resolution mode			52,734			52,734		SPS
	Low-Power mode			52,734			52,734		SPS
	Low-Speed mode			10,547			10,547		SPS
Integral nonlinearity (INL) ⁽⁵⁾		Differential input, V _{CM} = 2.5V		±0.0003	±0.0012			±0.0014	% FSR ⁽²⁾
Offset error				0.25	2			2	mV
Offset drift				0.8					µV/°C
Gain error				0.1	0.5			0.5	% FSR
Gain drift				1.3					ppm/°C
	High-Speed mode	Shorted input		8.5	21			21	μV, rms
	High-Resolution mode	Shorted input		5.5	13			13	μV, rms
Noise	Low-Power mode	Shorted input		8.5	21			21	μV, rms
	Low-Speed mode	Shorted input		8.0	21			21	μV, rms
Common-mode re	jection	$f_{CM} = 60Hz$	90	108		90			dB
	AVDD			80			80		dB
Power-supply rejection	DVDD	f _{PS} = 60Hz		85			85		dB
rejection	IOVDD			105			102		dB
V _{COM} output voltage	je	No load		AVDD/2			AVDD/2		V
AC Performance		+	1						
Crosstalk		f = 1kHz, -0.5dBFS ⁽⁶⁾		-107					dB
	High-Speed mode		98	106		96			dB
Signal to poice		V _{REF} = 2.5V	101	110		101			dB
Signal-to-noise ratio (SNR) ⁽⁷⁾ (unweighted)	High-Resolution mode	V _{REF} = 3V		111					dB
	Low-Power mode		98	106		97			dB
	Low-Speed mode		98	107		98			dB
Total harmonic dis		V _{IN} = 1kHz, –0.5dBFS		-108	-96			-96	dB
Spurious-free dyna				109					dB
Passband ripple	<u> </u>			±0.005					dB

(1) Minimum and maximum parameters are characterized for operation at $T_A = 175^{\circ}C$ but may not be production tested at that temperature. Production test limits with statistical guardbands are used to ensure high temperature performance.

(2) $FSR = full-scale range = 2V_{REF}$.

(3) $f_{CLK} = 32.768MHz$ max for High-Speed mode, and 27MHz max for all other modes. When $f_{CLK} > 27MHz$, operation is limited to Frame-Sync mode and $V_{REF} \le 2.6V$.

(4) SPS = samples per second.

(5) Best fit method.

- (6) Worst-case channel crosstalk between one or more channels.
- (7) Minimum SNR is ensured by the limit of the DC noise specification.
- (8) THD includes the first nine harmonics of the input signal; Low-Speed mode includes the first five harmonics.

Copyright © 2009–2013, Texas Instruments Incorporated



www.ti.com

ELECTRICAL CHARACTERISTICS (continued)

All specifications at $T_A = T_J = -55^{\circ}$ C to 210°C, AVDD = 5 V, DVDD = 1.8 V, IOVDD = 3.3 V, $f_{CLK} = 27$ MHz, VREFP = 2.5 V, VREFN = 0 V, and all channels active, unless otherwise noted.

			T _A = -	-55°C to 12	5°C	T _A = 210°C ⁽¹⁾			
PA	ARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	MIN	TYP	MAX	UNIT
Passband				0.453					Hz
-3dB Bandwidth					f _{DATA} 0.49 f _{DATA}				Hz
Stop band	High-Resolution mode		95	UNITA DATA					dB
attenuation	All other modes		100						u.D
			0.547		127.453				
Stop band	High-Resolution mode		f _{DATA}		f _{DATA}				Hz
Stop band	All other modes		0.547 f _{DATA}		63.453 f _{DATA}				Hz
Crown dolou	High-Resolution mode			39/f _{DATA}					S
Group delay	All other modes			38/f _{DATA}					S
Settling time	High-Resolution mode	Complete settling		78/f _{DATA}					S
(latency) All other modes		Complete settling		76/f _{DATA}					s
Voltage Reference	ce Inputs		1						
Reference input v	oltage (VPEE)	f _{CLK} = 27MHz	0.5	2.5	3.1	0.5	2.5	3.1	V
$(V_{REF} = VREFP -$	VREFN)	f _{CLK} = 32.768MHz ⁽³⁾	0.5	2.5	2.6	0.5	2.5	2.6	V
Negative reference input (VREFN)			AGND - 0.1		AGND + 0.1	AGND – 0.1		AGND + 0.1	V
Positive reference	e input (VREFP)		VREFN + 0.5		AVDD + 0.1	VREFN + 0.5		AVDD + 0.1	V
	High-Speed mode			0.65			0.65		kΩ
Reference Input impedance	High-Resolution mode			0.65			0.65		kΩ
	Low-Power mode			1.3			1.3		kΩ
	Low-Speed mode			6.5			6.5		kΩ
Digital Input/Out 3.6V)	put (IOVDD = 1.8V to							·	
VIH			0.7 IOVDD		IOVDD	0.7 IOVDD		IOVDD	V
V _{IL}			DGND		0.3 IOVDD	DGND		0.3 IOVDD	V
V _{OH}		I _{OH} = 4mA	0.8 IOVDD		IOVDD	0.8 IOVDD		IOVDD	V
V _{OL}		I _{OL} = 4mA	DGND		0.2 IOVDD	DGND		0.2 IOVDD	V
Input leakage		0 < V _{IN DIGITAL} < IOVDD			±10				μA
Master clock rate	(four)	High-Speed mode ⁽⁹⁾	0.1		32.768	0.1		32.768	MH:
	(ICLK)	Other modes	0.1		27	0.1		27	MH:
Power Supply		T	1						
AVDD			4.75	5	5.25	4.75	5	5.25	V
DVDD			1.65	1.8	1.95	1.65	1.8	1.95	V
IOVDD	1		1.65		3.6	1.65		3.6	V
	AVDD			1	10		65		μA
Power-down current	DVDD			1	50		200		μA
	IOVDD			1	11		25		μA
	High-Speed mode			97	145		135	185	mA
	High-Resolution mode			97	145		135	185	mA
AVDD current	Low-Power mode			44	64		60	84	mA
	Low-Speed mode			9	14		12	22	mA

(9) $f_{CLK} = 32.768MHz$ max for High-Speed mode, and 27MHz max for all other modes. When $f_{CLK} > 27MHz$, operation is limited to Frame-Sync mode and $V_{REF} \le 2.6V$.



ADS1278-HT

SBAS447E - MARCH 2009-REVISED APRIL 2013

www.ti.com

ELECTRICAL CHARACTERISTICS (continued)

All specifications at $T_A = T_J = -55^{\circ}$ C to 210°C, AVDD = 5 V, DVDD = 1.8 V, IOVDD = 3.3 V, $f_{CLK} = 27$ MHz, VREFP = 2.5 V, VREFN = 0 V, and all channels active, unless otherwise noted.

			T _A = -5	T _A = –55°C to 125°C		T _A =	210°C ⁽¹⁾		
PA	RAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	MIN	TYP	MAX	UNIT
	High-Speed mode			23	30		24	31	mA
DVDD current	High-Resolution mode			16	20		17	20	mA
	Low-Power mode			12	17		13	17	mA
	Low-Speed mode			2.5	4.5		3	5	mA
	High-Speed mode			0.25	1		0.3	1.15	mA
IOVDD current	High-Resolution mode			0.125	0.6		0.2	0.75	mA
IOVDD current	Low-Power mode			0.125	0.6		0.2	0.75	mA
	Low-Speed mode			0.035	0.3		0.1	0.45	mA
	High-Speed mode			530	785			985	mW
Power dissipation	High-Resolution mode			515	765			985	mW
	Low-Power mode			245	355			455	mW
	Low-Speed mode			50	80			120	mW



www.ti.com

ELECTRICAL CHARACTERISTICS

All specifications at $T_A = -55^{\circ}$ C to 175°C, AVDD = 5 V, DVDD = 1.8 V, IOVDD = 3.3 V, $f_{CLK} = 27$ MHz, VREFP = 2.5 V, VREFN = 0 V, and all channels active, unless otherwise noted.

			T _A = -55°C to 1	75°C (PAP P	ackage)	
P	ARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Analog Inputs			-			
Full-scale input voltage	(FSR ⁽¹⁾)	$V_{IN} = (AINP - AINN)$		$\pm V_{REF}$		V
Absolute input voltage		AINP or AINN to AGND	AGND – 0.1		AVDD + 0.1	V
Common-mode input vo	Itage (V _{CM})	$V_{CM} = (AINP + AINN)/2$		2.5		V
	High-Speed mode			14		kΩ
Differential input impedance	High-Resolution mode			14		kΩ
	Low-Power mode			28		kΩ
	Low-Speed mode			140		kΩ
DC Performance					I	
Resolution		No missing codes	24			Bits
		f _{CLK} = 32.768MHz ⁽²⁾		128,000		SPS
	High-Speed mode	f _{CLK} = 27MHz		105,469		SPS ⁽³⁾
Data rate (f _{DATA})	High-Resolution mode			52,734		SPS
	Low-Power mode			52,734		SPS
	Low-Speed mode			10,547		SPS
Integral nonlinearity (INL) ⁽⁴⁾	Differential input, $V_{CM} = 2.5V$		±0.0003	±0.0015	% FSR ⁽¹⁾
Offset error				0.25	3	mV
Offset drift				0.8		µV/°C
Gain error				0.1	0.5	% FSR
Gain drift				1.3		ppm/°C
	High-Speed mode	Shorted input		8.5	68	μV, rms
	High-Resolution mode	Shorted input		5.5	13	μV, rms
Noise	Low-Power mode	Shorted input		8.5	21	μV, rms
	Low-Speed mode	Shorted input		8.0	21	μV, rms
Common-mode rejectior	1	f _{CM} = 60Hz	90	108		dB
	AVDD			80		dB
Power-supply rejection	DVDD	f _{PS} = 60Hz		85		dB
	IOVDD			105		dB
V _{COM} output voltage		No load		AVDD/2		V
AC Performance						
Crosstalk		f = 1kHz, -0.5dBFS ⁽⁵⁾		-107		dB
	High-Speed mode		88	106		dB
		V _{REF} = 2.5V	101	110		dB
Signal-to-noise ratio (SNR) ⁽⁶⁾ (unweighted)	High-Resolution mode	V _{REF} = 3V		111		dB
	Low-Power mode		98	106		dB
	Low-Speed mode		98	107		dB
Total harmonic distortior	n (THD) ⁽⁷⁾	V _{IN} = 1kHz, –0.5dBFS		-108	-96	dB
Spurious-free dynamic r				109		dB
Passband ripple				±0.005		dB
Passband				0.453 f _{DATA}		Hz
-3dB Bandwidth				0.49 f _{DATA}		Hz

(1) FSR = full-scale range = 2V_{REF}.
 (2) f_{CLK} = 32.768MHz max for High-Speed mode, and 27MHz max for all other modes. When f_{CLK} > 27MHz, operation is limited to Frame-Sync mode and V_{REF} ≤ 2.6V.
 (3) SPS = samples per second.

(4) Best fit method.

- Worst-case channel crosstalk between one or more channels. (5)
- (6) Minimum SNR is ensured by the limit of the DC noise specification.
- THD includes the first nine harmonics of the input signal; Low-Speed mode includes the first five harmonics. (7)
- 16 Submit Documentation Feedback



www.ti.com

ELECTRICAL CHARACTERISTICS (continued)

All specifications at $T_A = -55^{\circ}$ C to 175°C, AVDD = 5 V, DVDD = 1.8 V, IOVDD = 3.3 V, $f_{CLK} = 27$ MHz, VREFP = 2.5 V, VREFN = 0 V, and all channels active, unless otherwise noted.

			T _A = -55°C to 1	75°C (PAP Packa	ge)	
P	ARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Stop band attenuation	High-Resolution mode		95			dB
	All other modes		100			
Stop band	High-Resolution mode		0.547 f _{DATA}	12	7.453 f _{DATA}	Hz
Stop band	All other modes		0.547 f _{DATA}	6	3.453 f _{DATA}	Hz
Group delay	High-Resolution mode			39/f _{DATA}		S
Group delay	All other modes			38/f _{DATA}		s
Settling time (latency)	High-Resolution mode	Complete settling		78/f _{DATA}		S
Getting time (latency)	All other modes	Complete settling		76/f _{DATA}		S
Voltage Reference Inp	uts					
Reference input voltage		f _{CLK} = 27MHz	0.5	2.5	3.1	V
(V _{REF} = VREFP – VREF		f _{CLK} = 32.768MHz ⁽²⁾	0.5	2.5	2.6	V
Negative reference inpu	it (VREFN)		AGND – 0.1	AC	OND + 0.1	V
Positive reference input	(VREFP)		VREFN + 0.5	A۱	/DD + 0.1	V
	High-Speed mode			0.65		kΩ
Reference Input	High-Resolution mode			0.65		kΩ
impedance	Low-Power mode			1.3		kΩ
	Low-Speed mode			6.5		kΩ
Digital Input/Output (I	OVDD = 1.8V to 3.6V)					
V _{IH}			0.7 IOVDD	IC	OVDD	V
V _{IL}			DGND	10	0.3 DVDD	V
V _{OH}		$I_{OH} = 4mA$	0.8 IOVDD	IC	OVDD	V
V _{OL}		$I_{OL} = 4mA$	DGND	IC	0.2 OVDD	V
Input leakage		0 < V _{IN DIGITAL} < IOVDD			±10	μA
Maatar alaak rata (f)		High-Speed mode ⁽⁸⁾	0.1	3	2.768	MHz
Master clock rate (f _{CLK})		Other modes	0.1		27	MHz
Power Supply						
AVDD			4.75	5	5.25	V
DVDD			1.65	1.8	1.95	V
IOVDD			1.65		3.6	V
	AVDD			40	60	μA
Power-down current	DVDD			50	85	μA
	IOVDD			24	40	μA
	High-Speed mode			130	150	mA
	High-Resolution mode			130	150	mA
AVDD current	Low-Power mode			58	68	mA
	Low-Speed mode			13	17	mA
	High-Speed mode			23	30	mA
	High-Resolution mode			16	20	mA
DVDD current	Low-Power mode			12	17	mA
	Low-Speed mode			3.5	4.5	mA

(8) $f_{CLK} = 32.768MHz$ max for High-Speed mode, and 27MHz max for all other modes. When $f_{CLK} > 27MHz$, operation is limited to Frame-Sync mode and $V_{REF} \le 2.6V$.



www.ti.com

ELECTRICAL CHARACTERISTICS (continued)

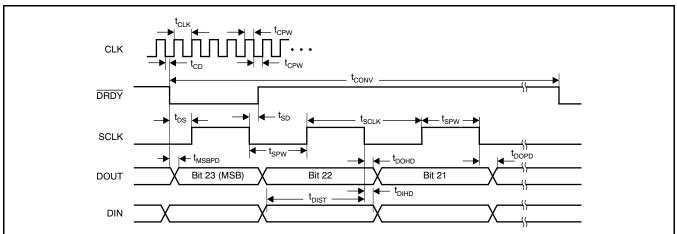
All specifications at $T_A = -55^{\circ}$ C to 175°C, AVDD = 5 V, DVDD = 1.8 V, IOVDD = 3.3 V, $f_{CLK} = 27$ MHz, VREFP = 2.5 V, VREFN = 0 V, and all channels active, unless otherwise noted.

			T _A = -55°C to 175°C (PAP Package)			
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
	High-Speed mode			0.5	1.1	mA
IOVDD current	High-Resolution mode			0.3	0.6	mA
IOVDD current	Low-Power mode			0.3	0.6	mA
	Low-Speed mode			0.1	0.5	mA
	High-Speed mode			530	805	mW
Power dissipation	High-Resolution mode			515	785	mW
	Low-Power mode			245	440	mW
	Low-Speed mode			50	89	mW



SBAS447E - MARCH 2009-REVISED APRIL 2013

TIMING CHARACTERISTICS: SPI FORMAT



TIMING REQUIREMENTS: SPI FORMAT⁽¹⁾

For $T_{A} = -40^{\circ}$ C to 125°C. IOVDD = 1.65 V to 3.6 V. and DVDD = 1.65 V to 1.95 V.

SYMBOL	PARAMETER	MIN	TYP	MAX	UNIT
t _{CLK}	CLK period (1/f _{CLK}) ⁽²⁾	37		10,000	ns
t _{CPW}	CLK positive or negative pulse width	15			ns
CONV	Conversion period (1/f _{DATA}) ⁽³⁾	256		2560	t _{CLK}
t _{CD} ⁽⁴⁾	Falling edge of CLK to falling edge of DRDY		22		ns
t _{DS} ⁽⁴⁾	Falling edge of DRDY to rising edge of first SCLK to retrieve data	1			t _{CLK}
t _{MSBPD}	DRDY falling edge to DOUT MSB valid (propagation delay)			16	ns
t _{SD} ⁽⁴⁾	Falling edge of SCLK to rising edge of DRDY		18		ns
t _{SCLK} ⁽⁵⁾	SCLK period	1			t _{CLK}
SPW	SCLK positive or negative pulse width	0.4			t _{CLK}
t _{DOHD} (4) (6)	SCLK falling edge to new DOUT invalid (hold time)	10			ns
t _{DOPD} ⁽⁴⁾	SCLK falling edge to new DOUT valid (propagation delay)			32	ns
t _{DIST}	New DIN valid to falling edge of SCLK (setup time)	6			ns
t _{DIHD} ⁽⁶⁾	Old DIN valid to falling edge of SCLK (hold time)	6			ns

Timing parameters are characerized or guranteed by design for specified temperature but not production tested. (1)

(2)

 $f_{CLK} = 27$ MHz maximum. Depends on MODE[1:0] and CLKDIV selection. See Table 10 (f_{CLK}/f_{DATA}). (3)

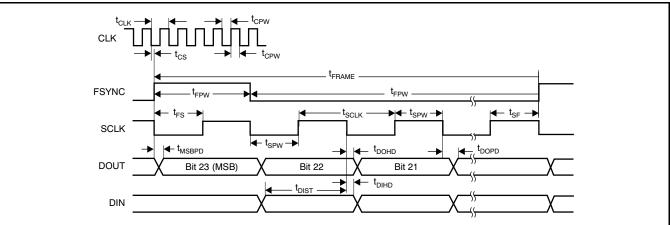
Load on \overline{DRDY} and $\overline{DOUT} = 20$ pF.

(4) (5)

For best performance, limit f_{SCLK}/f_{CLK} to ratios of 1, 1/2, 1/4, 1/8, etc. t_{DOHD} (DOUT hold time) and t_{DIHD} (DIN hold time) are specified under opposite worst-case conditions (digital supply voltage and ambient temperature). Under equal conditions, with DOUT connected directly to DIN, the timing margin is >4ns. (6)







TIMING REQUIREMENTS: FRAME-SYNC FORMAT⁽¹⁾

For $T_A = -40^{\circ}$ C to 125° C, IOVDD = 1.65 V to 3.6 V, and DVDD = 1.65 V to 1.95 V.

SYMBOL	PARAMETER		MIN	TYP MAX	UNIT
		All modes	37	10,000	ns
t _{CLK}	CLK period (1/f _{CLK})	High-Speed mode only	30.5		ns
t _{CPW}	CLK positive or negative pulse width		12		ns
t _{CS}	Falling edge of CLK to falling edge of S	CLK	-0.25	0.25	t _{CLK}
t _{FRAME}	Frame period (1/f _{DATA}) ⁽²⁾		256	2560	t _{CLK}
t _{FPW}	FSYNC positive or negative pulse width		1		t _{SCLK}
t _{FS}	Rising edge of FSYNC to rising edge of SCLK		5		ns
t _{SF}	Rising edge of SCLK to rising edge of FSYNC		5		ns
t _{SCLK}	SCLK period ⁽³⁾		1		t _{CLK}
t _{SPW}	SCLK positive or negative pulse width		0.4		t _{CLK}
t _{DOHD} ⁽⁴⁾ (5)	SCLK falling edge to old DOUT invalid	(hold time)	10		ns
t _{DOPD} ⁽⁵⁾	SCLK falling edge to new DOUT valid (propagation delay)		31	ns
t _{MSBPD}	FSYNC rising edge to DOUT MSB valid (propagation delay)			31	ns
t _{DIST}	New DIN valid to falling edge of SCLK	(setup time)	6		ns
t _{DIHD} ⁽⁴⁾	Old DIN valid to falling edge of SCLK (I	nold time)	6		ns

(1)

(2)

(3)

Timing parameters are characerized or guranteed by design for specified temperature but not production tested. Depends on MODE[1:0] and CLKDIV selection. See Table 10 (f_{CLK}/f_{DATA}). SCLK must be continuously running and limited to ratios of 1, 1/2, 1/4, and 1/8 of f_{CLK} . t_{DOHD} (DOUT hold time) and t_{DIHD} (DIN hold time) are specified under opposite worst-case conditions (digital supply voltage and (4)

ambient temperature). Under equal conditions, with DOUT connected directly to DIN, the timing margin is >4 ns.

(5) Load on DOUT = 20 pF.



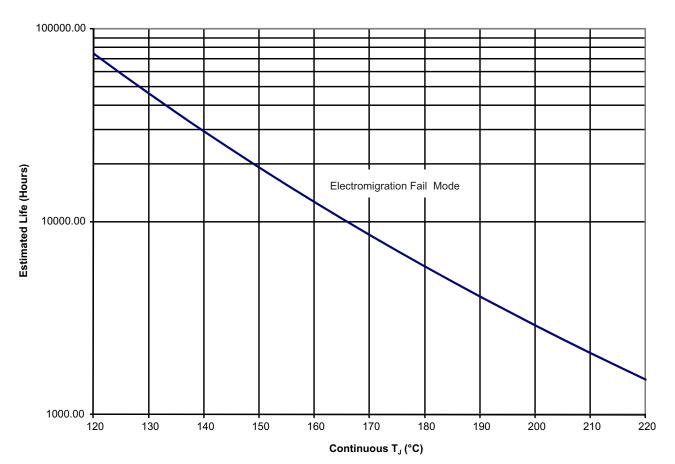


Figure 2. ADS1278 Operating Life Derating Chart

Notes:

EXAS

www.ti.com

NSTRUMENTS

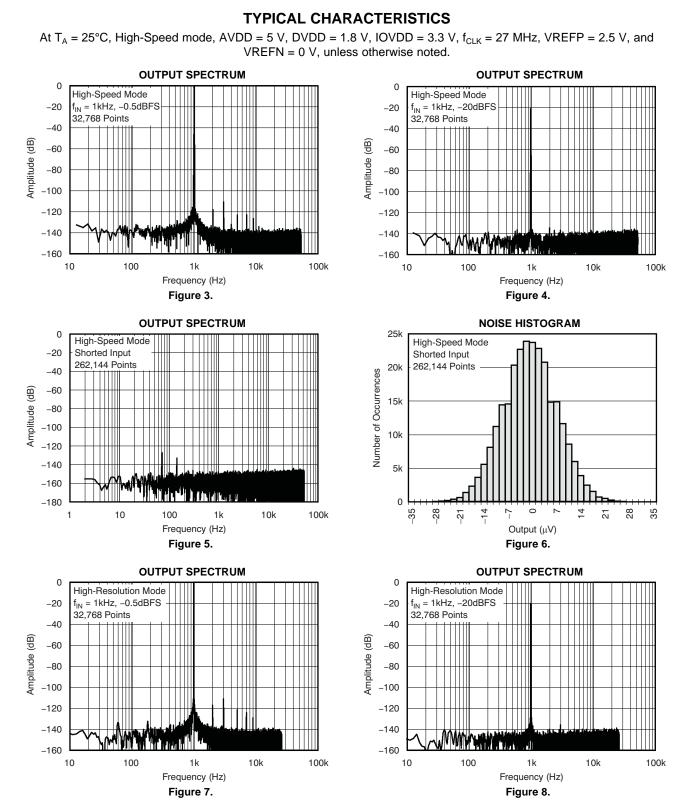
- 1. See datasheet for absolute maximum and minimum recommended operating conditions.
- 2. Sillicon operating life design goal is 10 years at 110°C junction temperature.
- 3. The predicted operating lifetime vs. junction temperature is based on reliability modeling using electromigration as the dominant failure mechanism affecting device wearout for the specific device process and design characteristics.
- 4. This device is qualified for 1000 hours of continuous operation at maximum rated temperature

ADS1278-HT

TEXAS INSTRUMENTS

SBAS447E-MARCH 2009-REVISED APRIL 2013

www.ti.com

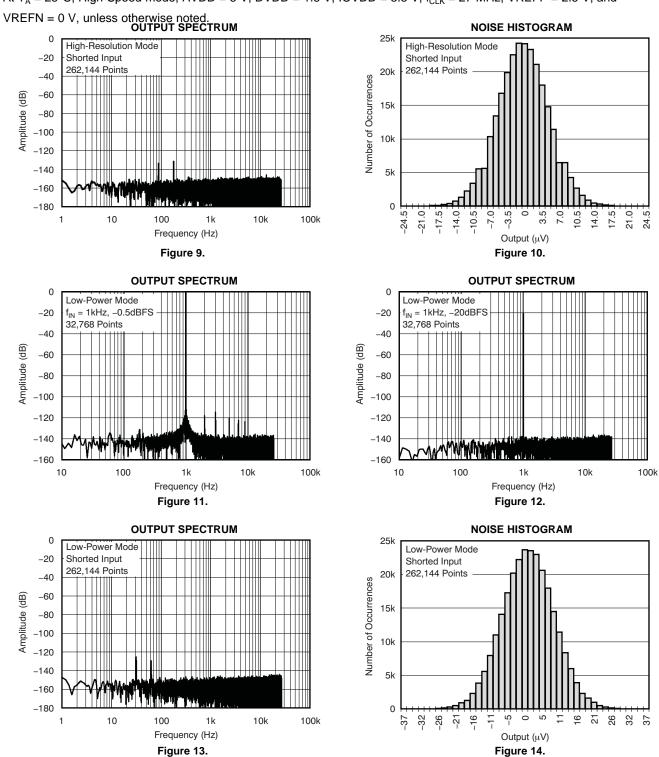






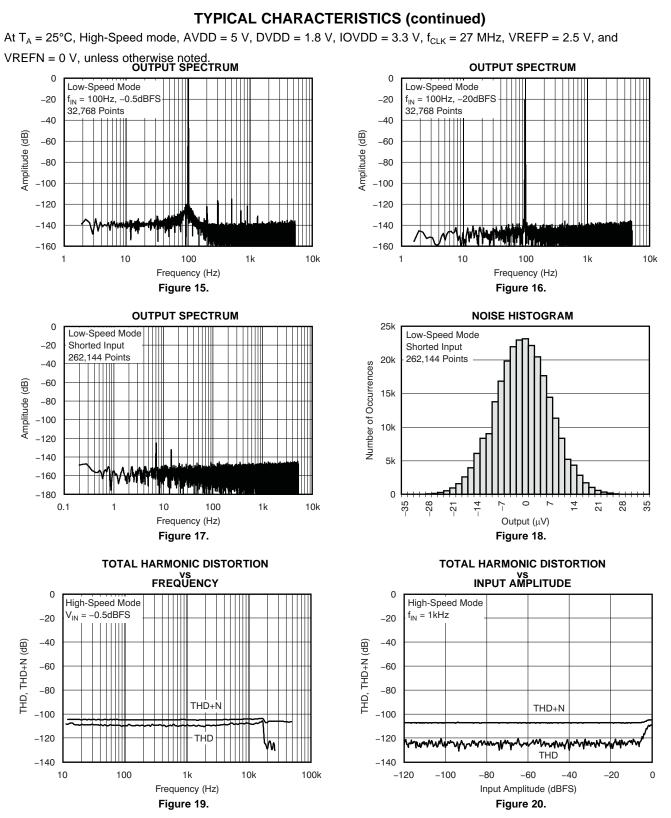
TYPICAL CHARACTERISTICS (continued)

At $T_A = 25^{\circ}$ C, High-Speed mode, AVDD = 5 V, DVDD = 1.8 V, IOVDD = 3.3 V, $f_{CLK} = 27$ MHz, VREFP = 2.5 V, and



TEXAS INSTRUMENTS

www.ti.com

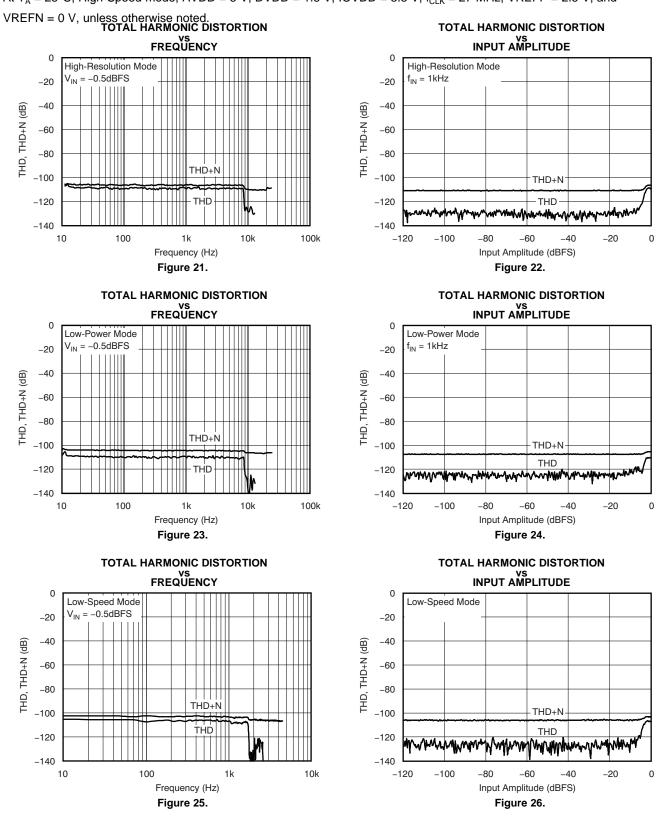




www.ti.com

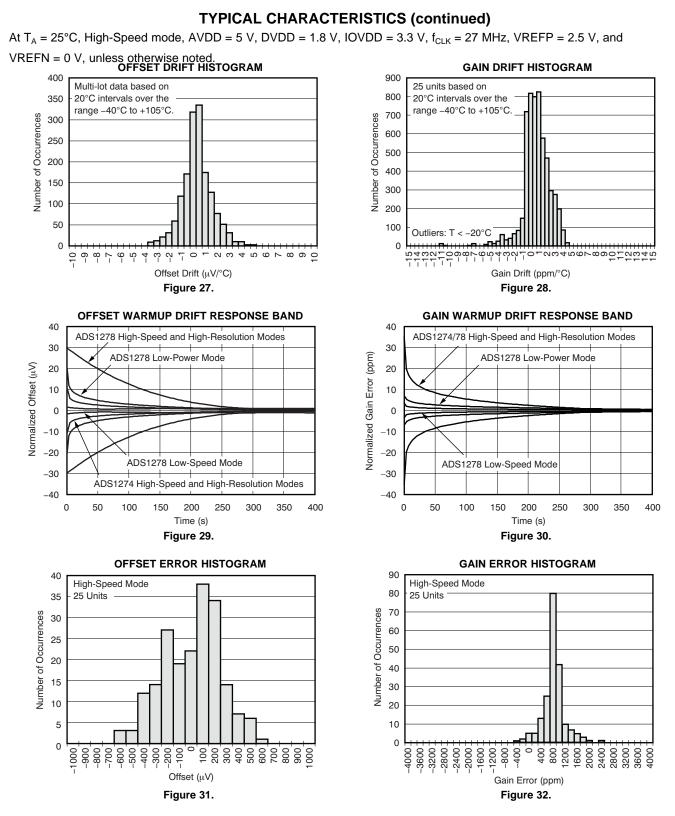
TYPICAL CHARACTERISTICS (continued)

At $T_A = 25^{\circ}$ C, High-Speed mode, AVDD = 5 V, DVDD = 1.8 V, IOVDD = 3.3 V, $f_{CLK} = 27$ MHz, VREFP = 2.5 V, and



TEXAS INSTRUMENTS

www.ti.com

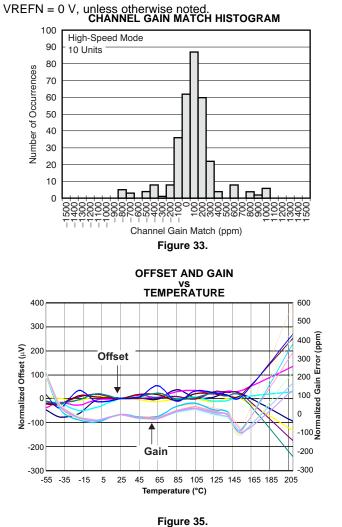


Copyright © 2009–2013, Texas Instruments Incorporated

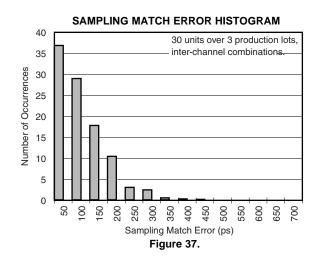


TYPICAL CHARACTERISTICS (continued)

At T_A = 25°C, High-Speed mode, AVDD = 5 V, DVDD = 1.8 V, IOVDD = 3.3 V, f_{CLK} = 27 MHz, VREFP = 2.5 V, and

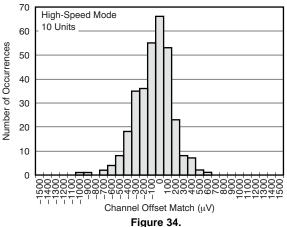




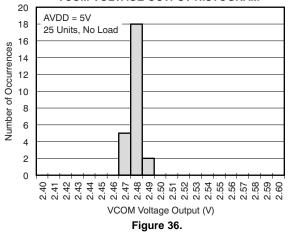


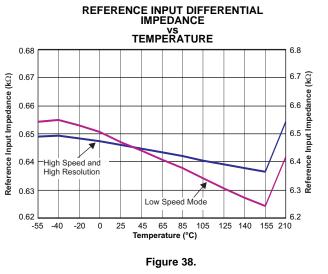


SBAS447E - MARCH 2009-REVISED APRIL 2013



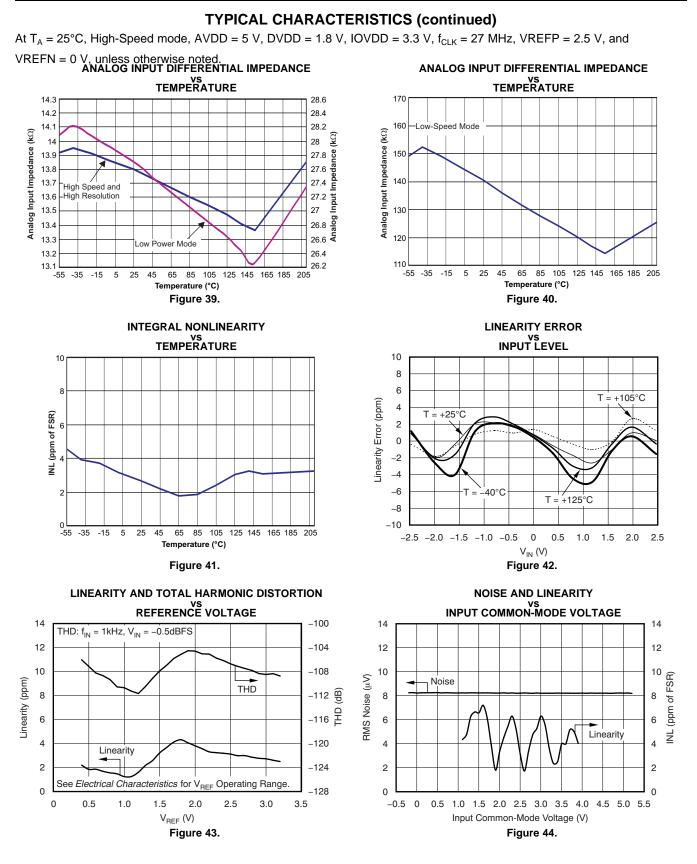






TEXAS INSTRUMENTS

www.ti.com



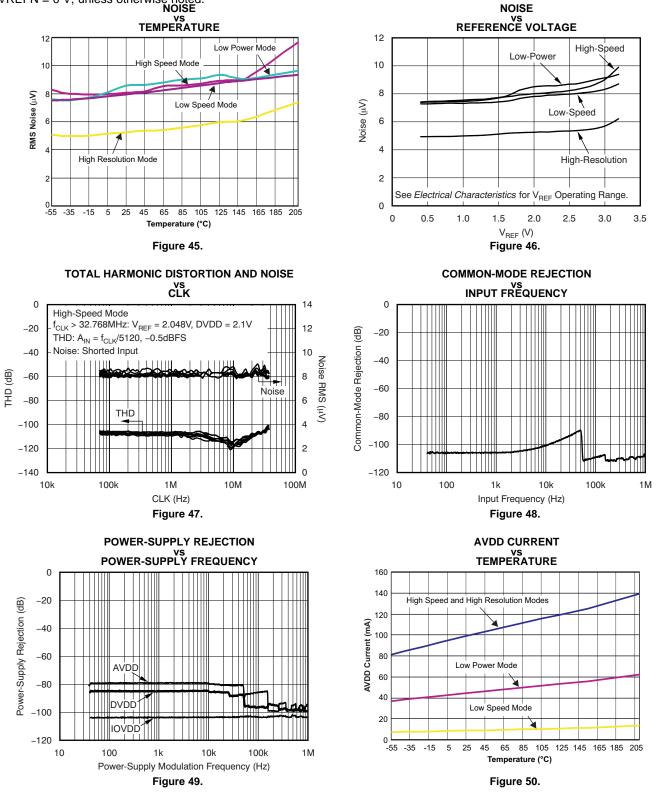


www.ti.com

TYPICAL CHARACTERISTICS (continued)

At $T_A = 25^{\circ}$ C, High-Speed mode, AVDD = 5 V, DVDD = 1.8 V, IOVDD = 3.3 V, $f_{CLK} = 27$ MHz, VREFP = 2.5 V, and

VREFN = 0 V, unless otherwise noted.

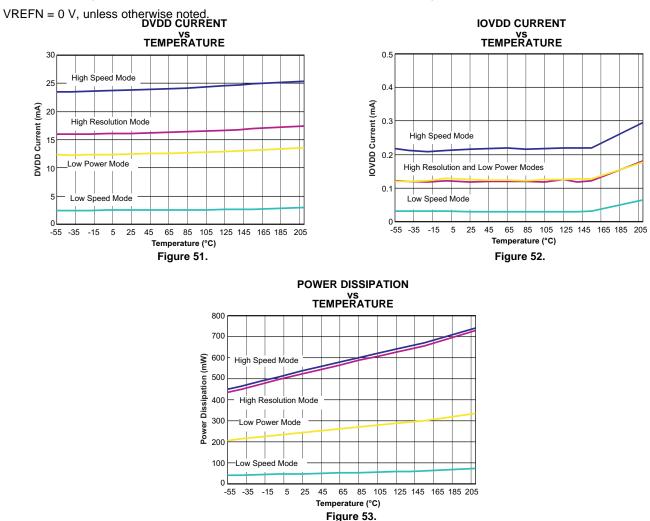


TEXAS INSTRUMENTS

www.ti.com

TYPICAL CHARACTERISTICS (continued)

At $T_A = 25^{\circ}$ C, High-Speed mode, AVDD = 5 V, DVDD = 1.8 V, IOVDD = 3.3 V, $f_{CLK} = 27$ MHz, VREFP = 2.5 V, and





OVERVIEW

The ADS1278 is an octal 24-bit, delta-sigma ADC based on the single-channel ADS1271. It offers the combination of outstanding dc accuracy and superior ac performance. Figure 54 shows the block diagram. The converter is comprised of eight advanced, 6th-order, chopper-stabilized, delta-sigma modulators followed by low-ripple, linear phase FIR filters. The modulators measure the differential input signal, $V_{IN} = (AINP - AINN)$, against the differential reference, $V_{REF} = (VREFP - VREFN)$. The digital filters receive the modulator signal and provide a low-noise digital output. To allow tradeoffs among speed, resolution, and power, four operating modes are supported:

High-Speed, High-Resolution, Low-Power, and Low-Speed. Table 5 summarizes the performance of each mode.

In High-Speed mode, the maximum data rate is 128 kSPS (when operating at 128 kSPS, Frame-Sync format must be used). In High-Resolution mode, the SNR = 111dB (V_{REF} = 3.0 V); in Low-Power mode, the power dissipation is 31 mW/channel; and in Low-Speed mode, the power dissipation is only 7 mW/channel at 10.5 kSPS. The digital filters can be bypassed, enabling direct access to the modulator output.

The ADS1278 is configured by simply setting the appropriate I/O pins—there are no registers to program. Data are retrieved over a serial interface that supports both SPI and Frame-Sync formats. The ADS1278 has a daisy-chainable output and the ability to synchronize externally, so it can be used conveniently in systems requiring more than eight channels.

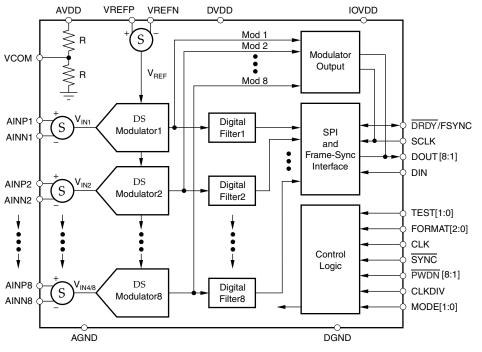


Figure 54. Block Diagram

MODE	MAX DATA RATE (SPS)	PASSBAND (kHz)	SNR (dB)	NOISE (µV _{RMS})	POWER/CHANNEL (mW)
High-Speed	128,000	57,984	106	8.5	70
High-Resolution	52,734	23,889	110	5.5	64
Low-Power	52,734	23,889	106	8.5	31
Low-Speed	10,547	4,798	107	8.0	7

Table 5. Operating Mode Performance Summary

FUNCTIONAL DESCRIPTION

The ADS1278 is a delta-sigma ADC consisting of eight independent converters that digitize eight input signals in parallel.

The converter is composed of two main functional blocks to perform the ADC conversions: the modulator and the digital filter. The modulator samples the input signal together with sampling the reference voltage to produce a 1s density output stream. The density of the output stream is proportional to the analog input level relative to the reference voltage. The pulse stream is filtered by the internal digital filter where the output conversion result is produced.

In operation, the input signal is sampled by the modulator at a high rate (typically 64x higher than the final output data rate). The quantization noise of the modulator is moved to a higher frequency range where the internal digital filter removes it. Oversampling results in very low levels of noise within the signal passband.

Since the input signal is sampled at a very high rate, input signal aliasing does not occur until the input signal frequency is at the modulator sampling rate. This architecture greatly relaxes the requirement of external antialiasing filters because of the high modulator sampling rate.

SAMPLING APERTURE MATCHING

The ADS1278 converter operates from the same CLK input. The CLK input controls the timing of the modulator sampling instant. The converter is designed such that the sampling skew, or modulator sampling aperture match between channels, is controlled. Furthermore, the digital filters are synchronized to start the convolution phase at the same modulator clock cycle. This design results in excellent phase match among the ADS1278 channels.

Figure 37 shows the inter-device channel sample matching for the ADS1278.

FREQUENCY RESPONSE

The digital filter sets the overall frequency response. The filter uses a multi-stage FIR topology to provide linear phase with minimal passband ripple and high stop band attenuation. The filter coefficients are identical to the coefficients used in the ADS1271. The oversampling ratio of the digital filter (that is, the ratio of the modulator sampling to the output data rate, or f_{MOD}/f_{DATA}) is a function of the selected mode, as shown in Table 6.

Table 6. Oversampling Ratio versus Mode

MODE SELECTION	OVERSAMPLING RATIO (f _{MOD} /f _{DATA})
High-Speed	64
High-Resolution	128
Low-Power	64
Low-Speed	64



FEXAS

www.ti.com



ADS1278-HT

SBAS447E - MARCH 2009-REVISED APRIL 2013

www.ti.com

High-Speed, Low-Power, and Low-Speed Modes

The digital filter configuration is the same in High-Speed, Low-Power, and Low-Speed modes with the oversampling ratio set to 64. Figure 55 shows the frequency response in High-Speed, Low-Power, and Low-Speed modes normalized to f_{DATA} . Figure 56 shows the passband ripple. The transition from passband to stop band is shown in Figure 57. The overall frequency response repeats at 64x multiples of the modulator frequency f_{MOD} , as shown in Figure 58.

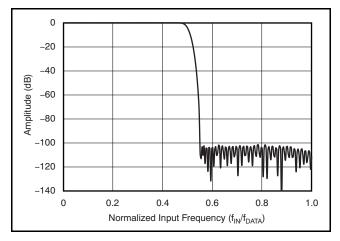


Figure 55. Frequency Response for High-Speed, Low-Power, and Low-Speed Modes

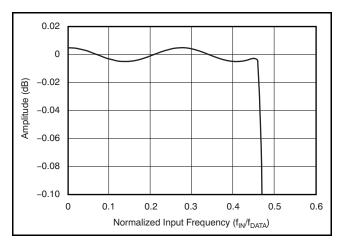


Figure 56. Passband Response for High-Speed, Low-Power, and Low-Speed Modes

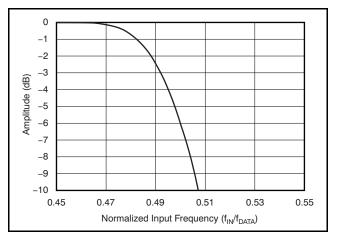


Figure 57. Transition Band Response for High-Speed, Low-Power, and Low-Speed Modes

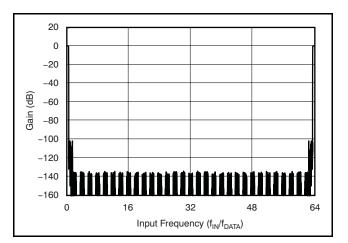


Figure 58. Frequency Response Out to f_{MOD} for High-Speed, Low-Power, and Low-Speed Modes

These image frequencies, if present in the signal and not externally filtered, will fold back (or alias) into the passband, causing errors. The stop band of the ADS1278 provides 100 dB attenuation of frequencies that begin just beyond the passband and continue out to f_{MOD} . Placing an antialiasing, low-pass filter in front of the ADS1278 inputs is recommended to limit possible high-amplitude, out-of-band signals and noise. Often, a simple RC filter is sufficient. Table 7 lists the image rejection versus external filter order.

Table 7. Antialiasing Filter Order Image Rejection

ANTIALIASING	IMAGE REJI (f _{–3dB} a	ECTION (dB) t f _{DATA})
FILTER ORDER	HS, LP, LS	HR
1	39	45
2	75	87
3	111	129

High-Resolution Mode

The oversampling ratio is 128 in High-Resolution mode. Figure 59 shows the frequency response in High-Resolution mode normalized to f_{DATA} . Figure 60 shows the passband ripple, and the transition from passband to stop band is shown in Figure 61. The overall frequency response repeats at multiples of the modulator frequency f_{MOD} (128 × f_{DATA}), as shown in Figure 62. The stop band of the ADS1278 provides 100 dB attenuation of frequencies that begin just beyond the passband and continue out to f_{MOD} . Placing an antialiasing, low-pass filter in front of the ADS1278 inputs is recommended to limit possible high-amplitude out-of-band signals and noise. Often, a simple RC filter is sufficient. Table 7 lists the image rejection versus external filter order.

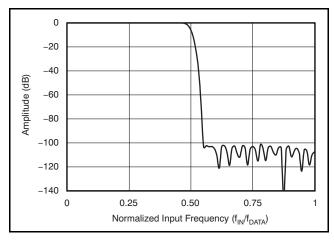


Figure 59. Frequency Response for High-Resolution Mode

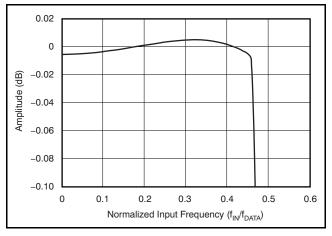


Figure 60. Passband Response for High-Resolution Mode



www.ti.com

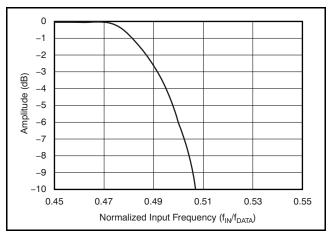


Figure 61. Transition Band Response for High-Resolution mode

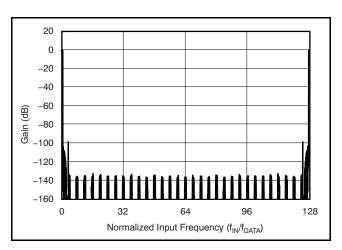


Figure 62. Frequency Response Out to f_{MOD} for High-Resolution Mode



PHASE RESPONSE

The ADS1278 incorporates a multiple stage, linear phase digital filter. Linear phase filters exhibit constant delay time versus input frequency (constant group delay). This characteristic means the time delay from any instant of the input signal to the same instant of the output data is constant and is independent of input signal frequency. This behavior results in essentially zero phase errors when analyzing multi-tone signals.

SETTLING TIME

As with frequency and phase response, the digital filter also determines settling time. Figure 63 shows the output settling behavior after a step change on the analog inputs normalized to conversion periods. The X-axis is given in units of conversion. Note that after the step change on the input occurs, the output data change very little prior to 30 conversion periods. The output data are fully settled after 76 conversion periods for High-Speed and Low-Power modes, and 78 conversion periods for High-Resolution mode.

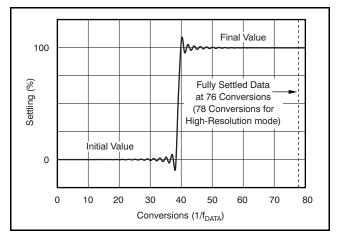


Figure 63. Step Response

DATA FORMAT

The ADS1278 outputs 24 bits of data in twos complement format.

A positive full-scale input produces an ideal output code of 7FFFFFh, and the negative full-scale input produces an ideal output code of 800000h. The output clips at these codes for signals exceeding fullscale. Table 8 summarizes the ideal output codes for different input signals.

Table 8. Ideal	Output Code	versus	Input S	ignal

SBAS447E - MARCH 2009 - REVISED APRIL 2013

INPUT SIGNAL V _{IN} (AINP – AINN)	IDEAL OUTPUT CODE ⁽¹⁾	
≥ +V _{REF}	7FFFFh	
$\frac{+V_{\text{REF}}}{2^{23}-1}$	000001h	
0	000000h	
$\frac{-V_{\text{REF}}}{2^{23}-1}$	FFFFFh	
$\leq -V_{REF} \left(\frac{2^{23}}{2^{23} - 1} \right)$	800000h	

(1) Excludes effects of noise, INL, offset, and gain errors.

ANALOG INPUTS (AINP, AINN)

The ADS1278 measures each differential input signal $V_{IN} = (AINP - AINN)$ against the common differential reference $V_{REF} = (VREFP - VREFN)$. The most positive measurable differential input is $+V_{REF}$, which produces the most positive digital output code of 7FFFFh. Likewise, the most negative measurable differential input is $-V_{REF}$, which produces the most negative digital output code of 800000h.

For optimum performance, the inputs of the ADS1278 are intended to be driven differentially. For singleended applications, one of the inputs (AINP or AINN) can be driven while the other input is fixed (typically to AGND or 2.5 V). Fixing the input to 2.5 V permits bipolar operation, thereby allowing full use of the entire converter range.

While the ADS1278 measures the differential input signal, the absolute input voltage is also important. This value is the voltage on either input (AINP or AINN) with respect to AGND. The range for this voltage is:

-0.1 V < (AINN or AINP) < AVDD + 0.1 V

If either input is taken below -0.4 V or above (AVDD + 0.4 V), ESD protection diodes on the inputs may turn on. If these conditions are possible, external Schottky clamp diodes or series resistors may be required to limit the input current to safe values (see the Absolute Maximum Ratings table).

The ADS1278 is a very high-performance ADC. For optimum performance, it is critical that the appropriate circuitry be used to drive the ADS1278 inputs. See the *Application Information* section for several recommended circuits.

The ADS1278 uses switched-capacitor circuitry to measure the input voltage. Internal capacitors are charged by the inputs and then discharged. Figure 64 shows a conceptual diagram of these circuits. Switch S_2 represents the net effect of the modulator circuitry in discharging the sampling capacitor; the actual implementation is different. The timing for switches S_1 and S_2 is shown in Figure 65. The sampling time (t_{SAMPLE}) is the inverse of modulator sampling frequency (f_{MOD}) and is a function of the mode, the CLKDIV input, and CLK frequency, as shown in Table 9.

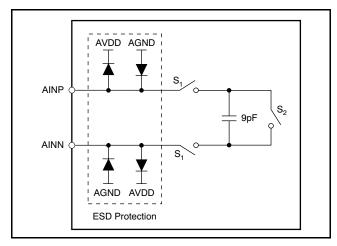


Figure 64. Equivalent Analog Input Circuitry

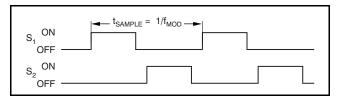


Figure 65. S₁ and S₂ Switch Timing for Figure 64

Table 9. Modulator Frequency (f _{MOD}) Mode Selection

MODE SELECTION	CLKDIV	f _{MOD}
High-Speed	1	f _{CLK} /4
High-Resolution	1	f _{CLK} /4
Low-Power	1	f _{CLK} /8
	0	f _{CLK} /4
Low-Speed	1	f _{CLK} /40
	0	f _{CLK} /8

The average load presented by the switched capacitor input can be modeled with an effective differential impedance, as shown in Figure 66. Note that the effective impedance is a function of f_{MOD} .



www.ti.com

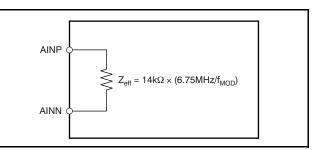


Figure 66. Effective Input Impedances

VOLTAGE REFERENCE INPUTS (VREFP, VREFN)

The voltage reference for the ADS1278 ADC is the differential voltage between VREFP and VREFN: $V_{RFF} = (VREFP - VREFN)$. The voltage reference is common to all channels. The reference inputs use a structure similar to that of the analog inputs with the equivalent circuitry on the reference inputs shown in Figure 67. As with the analog inputs, the load presented by the switched capacitor can be modeled with an effective impedance, as shown in Figure 68. However, the reference input impedance depends on the number of active (enabled) channels in addition to f_{MOD}. As a result of the change of reference input impedance caused by enabling and disabling channels, the regulation and setting time of the external reference should be noted, so as not to affect the readings.

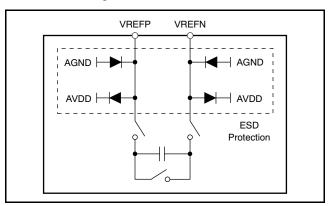


Figure 67. Equivalent Reference Input Circuitry

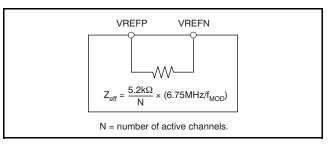


Figure 68. Effective Reference Impedance



ESD diodes protect the reference inputs. To keep these diodes from turning on, make sure the voltages on the reference pins do not go below AGND by more than 0.4 V, and likewise do not exceed AVDD by 0.4 V. If these conditions are possible, external Schottky clamp diodes or series resistors may be required to limit the input current to safe values (see the Absolute Maximum Ratings table).

Note that the valid operating range of the reference inputs is limited to the following parameters:

 $-0.1 \text{ V} \leq \text{VREFN} \leq +0.1 \text{ V}$

 $VREFN + 0.5 V \le VREFP \le AVDD + 0.1 V$

CLOCK INPUT (CLK)

The ADS1278 requires a clock input for operation. The individual converters of the ADS1278 operate from the same clock input. At the maximum data rate, the clock input can be either 27 MHz or 13.5 MHz for Low-Power mode, or 2 7MHz or 5.4 MHz for Low-Speed mode, determined by the setting of the CLKDIV input. For High-Speed mode, the maximum CLK input frequency is 32.768 MHz. For High-Resolution mode, the maximum CLK input frequency is 27 MHz. The selection of the external clock frequency (f_{CLK}) does not affect the resolution of the ADS1278. Use of a slower f_{CLK} can reduce the power consumption of an external clock buffer. The output data rate scales with clock frequency, down to a minimum clock frequency of $f_{CLK} = 100$ kHz. Table 10 summarizes the ratio of the clock input frequency (f_{CLK}) to data rate (f_{DATA}), maximum data rate and corresponding maximum clock input for the four operating modes.

As with any high-speed data converter, a high-quality, low-jitter clock is essential for optimum performance. Crystal clock oscillators are the recommended clock source. Make sure to avoid excess ringing on the clock input; keeping the clock trace as short as possible, and using a $50-\Omega$ series resistor placed close to the source end, often helps.

SBAS447E - MARCH 2009-REVISED APRIL 2013

Table 10. Clock Input O	ptions
-------------------------	--------

MODE SELECTION	MAX f _{CLK} (MHz)	CLKDIV	f _{clk} /f _{data}	DATA RATE (SPS)
High-Speed	32.768	1	256	128,000
High-Resolution	27	1	512	52,734
Low-Power	27	1	512	E0 704
Low-Power	13.5	0	256	52,734
Low Crood	27	1	2,560	10 5 17
Low-Speed	5.4	0	512	10,547

MODE SELECTION (MODE)

The ADS1278 supports four modes of operation: High-Speed, High-Resolution, Low-Power, and Low-Speed. The modes offer optimization of speed, resolution, and power. Mode selection is determined by the status of the digital input MODE[1:0] pins, as shown in Table 11. The ADS1278 continually monitors the status of the MODE pin during operation.

Table 11. Mode Selection

MODE[1:0]	MODE SELECTION	MAX f _{DATA} ⁽¹⁾
00	High-Speed	128,000
01	High-Resolution	52,734
10	Low-Power	52,734
11	Low-Speed	10,547

(1) f_{CLK} = 27 MHz max (32.768MHz max in High-Speed mode).

When using the SPI protocol, \overline{DRDY} is held high after a mode change occurs until settled (or valid) data are ready; see Figure 69 and Table 12.

In Frame-Sync protocol, the DOUT pins are held low after a mode change occurs until settled data are ready; see Figure 69 and Table 12. Data can be read from the device to detect when DOUT changes to logic 1, indicating that the data are valid.

TEXAS INSTRUMENTS

www.ti.com

SBAS447E-MARCH 2009-REVISED APRIL 2013

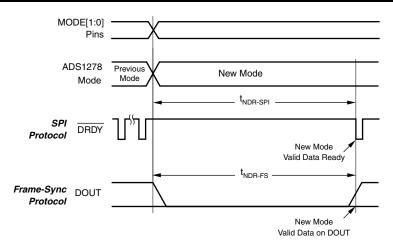


Figure 69. Mode Change Timing

SYMBOL	DESCRIPTION	MIN	TYP	MAX	UNITS
t _{NDR-SPI}	Time for new data to be ready (SPI)			129	Conversions (1/f _{DATA})
t _{NDR-FS}	Time for new data to be ready (Frame-Sync)	127		128	Conversions (1/f _{DATA})

SYNCHRONIZATION (SYNC)

<u>The ADS1278</u> can be synchronized by pulsing the SYNC pin low and then returning the pin high. When the pin goes low, the conversion process stops, and the internal counters used by the digital filter are reset. When the SYNC pin returns high, the conversion process restarts. Synchronization allows the conversion to be aligned with an external event, such as the changing of an external multiplexer on the analog inputs, or by a reference timing pulse.

Because the ADS1278 converters operate in <u>parallel</u> from the same master clock and use the same SYNC input control, they are always in synchronization with each other. The aperture match among internal channels is typically less than 500 ps. However, the synchronization of multiple devices is somewhat different. At device power-on, variations in internal reset thresholds from device to device may result in uncertainty in conversion timing.

The SYNC pin can be used to synchronize multiple devices to within the same CLK cycle. Figure 70 illustrates the timing requirement of SYNC and CLK in SPI format.

See Figure 71 for the Frame-Sync format timing requirement.

After synchronization, indication of valid data depends on whether SPI or Frame-Sync format was used.

In the SPI format, DRDY goes high as soon as SYNC is taken low; see Figure 70. After SYNC is returned high, DRDY stays high while the digital filter is settling. Once valid data are ready for retrieval, DRDY goes low.

In the Frame-Sync format, DOUT goes low as soon as SYNC is taken low; see Figure 71. After SYNC is returned high, DOUT stays low while the digital filter is settling. Once valid data are ready for retrieval, DOUT begins to output valid data. For proper synchronization, FSYNC, <u>SCLK</u>, and CLK must be established before taking SYNC high, and must then remain running. If the clock inputs (CLK, FSYNC or SCLK) are <u>subs</u>equently interrupted or reset, reassert the SYNC pin.

For consistent performance, re-assert SYNC after device power-on when data first appear.

38 Submit Documentation Feedback

Copyright © 2009–2013, Texas Instruments Incorporated



ADS1278-HT

www.ti.com

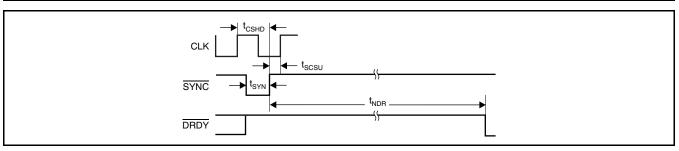


Figure 70. Synchronization Timing (SPI Protocol)

Table 13. SPI Protocol

SYMBOL	DESCRIPTION	MIN	TYP	MAX	UNITS
t _{CSHD}	CLK to SYNC hold time	10			ns
t _{SCSU}	SYNC to CLK setup time	5			ns
t _{SYN}	Synchronize pulse width	1			CLK periods
t _{NDR}	Time for new data to be ready			129	Conversions (1/f _{DATA})

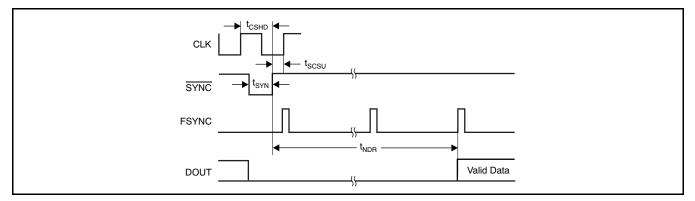


Figure 71. Synchronization Timing (Frame-Sync Protocol)

Table 14. Frame-Sync Protocol

SYMBOL	DESCRIPTION	MIN	TYP	MAX	UNITS
t _{CSHD}	CLK to SYNC hold time	10			ns
t _{SCSU}	SYNC to CLK setup time	5			ns
t _{SYN}	Synchronize pulse width	1			CLK periods
t _{NDR}	Time for new data to be ready	127		128	Conversions (1/f _{DATA})

SBAS447E - MARCH 2009-REVISED APRIL 2013

POWER-DOWN (PWDN)

The channels of the ADS1278 can be independently powered down by use of the PWDN inputs. To enter the power-down mode, hold the respective PWDN pin low for at least two CLK cycles. To exit power-down, return the corresponding PWDN pin high. Note that when all channels are powered down, the ADS1278 enters a microwatt (μ W) power state where all internal biasing is disabled. In this state, the TEST[1:0] input pins must be driven; all other input pins can float. The ADS1278 outputs remain driven.

As shown in Figure 72 and Table 15, a maximum of 130 conversion cycles must elapse for SPI interface, and 129 conversion cycles must elapse for Frame-Sync, before reading data after exiting power-down. Data from channels already running are not affected. The user software can perform the required delay time in any of the following ways:

- 1. Count the number of data conversions after taking the PWDN pin high.
- <u>Delay</u> 129/f_{DATA} or 130/f_{DATA} after taking the PWDN pins high, then read data.

3. Detect for non-zero data in the powered-up channel.

After powering up one or more channels, the channels are synchronized to each other. It is not necessary to use the SYNC pin to synchronize them.

When a channel is powered down in TDM data format, the data for that channel are either forced to zero (fixed-position TDM data mode) or replaced by shifting the data from the next channel into the vacated data position (dynamic-position TDM data mode).

In Discrete data format, the data are always forced to zero. When powering-up a channel in dynamicposition TDM data format mode, the channel data remain packed until the data are ready, at which time the data frame is expanded to include the justpowered channel data. See the *Data Format* section for details.

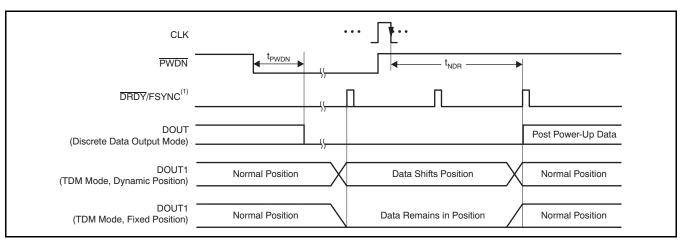


Figure 72. Power-Down Timing

SYMBOL	SYMBOL DESCRIPTION		TYP	MAX	UNITS
t _{PWDN}	PWDN pulse width to enter Power-Down mode	2			CLK periods
t _{NDR}	Time for new data ready (SPI)	129		130	Conversions (1/f _{DATA})
t _{NDR}	Time for new data ready (Frame-Sync)	128		129	Conversions (1/f _{DATA})



FORMAT[2:0]

Data can be read from the ADS1278 with two interface protocols (SPI or Frame-Sync) and several options of data formats (TDM/Discrete and Fixed/Dynamic data positions). The FORMAT[2:0] inputs are used to select among the options. Table 16 lists the available options. See the *DOUT Modes* section for details of the DOUT Mode and Data Position.

FORMAT[2:0]	INTERFACE PROTOCOL	DOUT MODE	DATA POSITION
000	SPI	TDM	Dynamic
001	SPI	TDM	Fixed
010	SPI	Discrete	_
011	Frame-Sync	TDM	Dynamic
100	Frame-Sync	TDM	Fixed
101	Frame-Sync	Discrete	—
110	Modulator Mode	_	_

Table 16. Data Output Format

SERIAL INTERFACE PROTOCOLS

Data are retrieved from the ADS1278 using the serial interface. Two protocols are available: SPI and Frame-Sync. The <u>same</u> pins are used for both interfaces: SCLK, DRDY/FSYNC, DOUT[8:1], and DIN. The FORMAT[2:0] pins select the desired interface protocol.

SPI SERIAL INTERFACE

The SPI-compatible format is a read-only interface. <u>Data ready</u> for retrieval are indicated by the falling DRDY output and are shifted out on the falling edge of SCLK, MSB first. The interface can be daisychained using the DIN input when using multiple devices. See the *Daisy-Chaining* section for more information.

NOTE: The SPI format is limited to a CLK input frequency of 27 MHz, maximum. For CLK input operation above 27 MHz (High-Speed mode only), use Frame-Sync format.

SCLK

The serial clock (SCLK) features a Schmitt-triggered input and shifts out data on DOUT on the falling edge. It also shifts in data on the falling edge on DIN when this pin is being used for daisy-chaining. The device shifts data out on the falling edge and the user normally shifts this data in on the rising edge. Even though the SCLK input has hysteresis, it is recommended to keep SCLK as clean as possible to prevent glitches from accidentally shifting the data.

SBAS447E - MARCH 2009-REVISED APRIL 2013

SCLK may be run as fast as the CLK frequency. SCLK may be either in free-running or stop-clock operation between conversions. Note that one f_{CLK} is required after the falling edge of DRDY until the first rising edge of SCLK. For best performance, limit f_{SCLK}/f_{CLK} to ratios of 1, 1/2, 1/4, 1/8, etc. When the device is configured for modulator output, SCLK becomes the modulator clock output (see the *Modulator Output* section).

DRDY/FSYNC (SPI Format)

In the SPI format, this pin functions as the DRDY output. It goes low when data are ready for retrieval and then returns high on the falling edge of the first subsequent SCLK. If data are not retrieved (that is, SCLK is held low), DRDY pulses high just before the next conversion data are ready, as shown in Figure 73. The new data are loaded within one CLK cycle before DRDY goes low. All data must be shifted out before this time to avoid being overwritten.

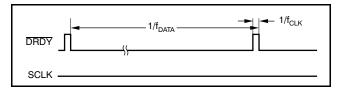


Figure 73. DRDY Timing with No Readback

DOUT

The conversion data are output on DOUT[8:1]. The MSB data are valid on DOUT[8:1] after DRDY goes low. Subsequent bits are shifted out with each falling edge of SCLK. If daisy-chaining, the data shifted in using DIN appear on DOUT after all channel data have been shifted out. When the device is configured for modulator output, DOUT[8:1] becomes the modulator data output for each channel (see the *Modulator Output* section).

DIN

This input is used when multiple ADS1278s are to be daisy-chained together. The DOUT1 pin of the first device connects to the DIN pin of the next, etc. It can be used with either the SPI or Frame-Sync formats. Data are shifted in on the falling edge of SCLK. When using only one ADS1278, tie DIN low. See the *Daisy-Chaining* section for more information.

SBAS447E - MARCH 2009 - REVISED APRIL 2013

FRAME-SYNC SERIAL INTERFACE

Frame-Sync format is similar to the interface often used on audio ADCs. It operates in slave fashion—the user must supply framing signal FSYNC (similar to the *left/right clock* on stereo audio ADCs) and the serial clock SCLK (similar to the *bit clock* on audio ADCs). The data are output MSB first or *leftjustified* on the rising edge of FSYNC. When using Frame-Sync format, the FSYNC and SCLK inputs must be continuously running with the relationships shown in the Frame-Sync Timing Requirements.

SCLK

The serial clock (SCLK) features a Schmitt-triggered input and shifts out data on DOUT on the falling edge. It also shifts in data on the falling edge on DIN when this pin is being used for daisy-chaining. Even though SCLK has hysteresis, it is recommended to keep SCLK as clean as possible to prevent glitches from accidentally shifting the data. When using Frame-Sync format, SCLK must run continuously. If it is shut down, the data readback will be corrupted. The number of SCLKs within a frame period (FSYNC clock) can be any power-of-2 ratio of CLK cycles (1, 1/2, 1/4, etc), as long as the number of cycles is sufficient to shift the data output from all channels within one frame. When the device is configured for modulator output, SCLK becomes the modulator clock output (see the *Modulator Output* section).

DRDY/FSYNC (Frame-Sync Format)

In Frame-Sync format, this pin is used as the FSYNC input. The frame-sync input (FSYNC) sets the frame period, which must be the same as the data rate. The required number of f_{CLK} cycles to each FSYNC period depends on the mode selection and the CLKDIV input. Table 10 indicates the number of CLK cycles to each frame (f_{CLK}/f_{DATA}). If the FSYNC period is not the proper value, data readback will be corrupted.

DOUT

The conversion data are shifted out on DOUT[8:1]. The MSB data become valid on DOUT[8:1] after FSYNC goes high. The subsequent bits are shifted out with each falling edge of SCLK. If daisy-chaining, the data shifted in using DIN appear on DOUT[8:1] after all channel data have been shifted out. When the device is configured for modulator output, DOUT becomes the modulator data output (see the *Modulator Output* section).

DIN

This input is used when multiple ADS1278s are to be daisy-chained together. It can be used with either SPI or Frame-Sync formats. Data are shifted in on the falling edge of SCLK. When using only one ADS1278, tie DIN low. See the *Daisy-Chaining* section for more information.

DOUT MODES

For both SPI and Frame-Sync interface protocols, the data are shifted out either through individual channel DOUT pins, in a parallel data format (Discrete mode), or the data for all channels are shifted out, in a serial format, through a common pin, DOUT1 (TDM mode).

TDM Mode

In TDM (time-division multiplexed) data output mode, the data for all channels are shifted out, in sequence, on a single pin (DOUT1). As shown in Figure 74, the data from channel 1 are shifted out first, followed by channel 2 data, etc. After the data from the last channel are shifted out, the data from the DIN input follow. The DIN is used to daisy-chain the data output from an additional ADS1278 or other compatible device. Note that when all channels of the ADS1278 are disabled, the interface is disabled, rendering the DIN input disabled as well. When one or more channels of the device are powered down, the data format of the TDM mode can be fixed or dynamic.

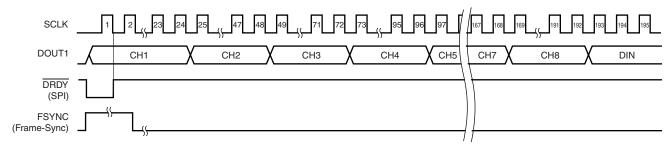


Figure 74. TDM Mode (All Channels Enabled)

Copyright © 2009–2013, Texas Instruments Incorporated



TDM Mode, Fixed-Position Data

In this TDM data output mode, the data position of the channels remain fixed, regardless of whether the channels are powered down. If a channel is powered down, the data are forced to zero but occupy the same position within the data stream. Figure 75 shows the data stream with channel 1 and channel 3 powered down.

TDM Mode, Dynamic Position Data

In this TDM data output mode, when a channel is powered down, the data from higher channels shift one position in the data stream to fill the vacated data slot. Figure 76 shows the data stream with channel 1 and channel 3 powered down.

SBAS447E - MARCH 2009-REVISED APRIL 2013

Discrete Data Output Mode

In Discrete data output mode, the channel data are shifted out in parallel using individual channel data output pins DOUT[8:1]. After the 24th SCLK, the channel data are forced to zero. The data are also forced to zero for powered down channels. Figure 77 shows the discrete data output format.

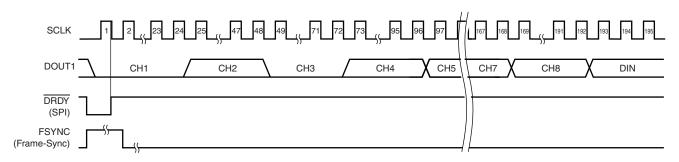


Figure 75. TDM Mode, Fixed-Position Data (Channels 1 and 3 Shown Powered Down)

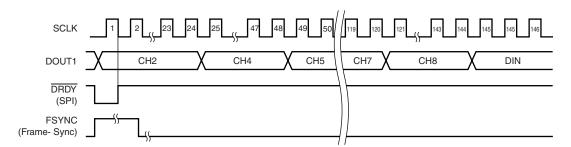
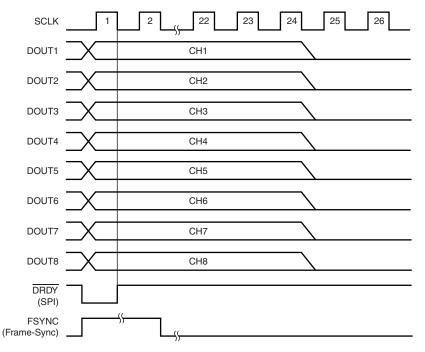


Figure 76. TDM Mode, Dynamic Position Data (Channels 1 and 3 Shown Powered Down)

NSTRUMENTS

FXAS

SBAS447E - MARCH 2009-REVISED APRIL 2013





DAISY-CHAINING

Multiple ADS1278s can be daisy-chained together to output data on a single pin. The DOUT1 data output pin of one device is connected to the DIN of the next device. As shown in Figure 78, the DOUT1 pin of device 1 provides the output data to a controller, and the DIN of device 2 is grounded. Figure 79 shows the data format when reading back data.

The maximum number of channels that may be daisy-chained in this way is limited by the frequency of f_{SCLK} , the mode selection, and the CLKDIV input. The frequency of f_{SCLK} must be high enough to completely shift the data out from all channels within one f_{DATA} period. Table 17 lists the maximum number of daisy-chained channels when $f_{SCLK} = f_{CLK}$.

To increase the number of data channels possible in a chain, a segmented DOUT scheme may be used, producing two data streams. Figure 80 illustrates four ADS1278s, with pairs of ADS1278s daisy-chained together. The channel data of each daisy-chained pair are shifted out in parallel and received by the processor through independent data channels.

Table 17. Maximum Channels in a Daisy-Chain

Table 17. Maximum Channels in a Daisy-Chain (f_{SCLK} = f_{CLK}) (continued)

MODE SELECTION	CLKDIV	MAXIMUM NUMBER OF CHANNELS			
High-Speed	1	10			
High-Resolution	1	21			
Low-Power	1	21			
Low-Power	0	10			
Low Speed	1	106			
Low-Speed	0	21			

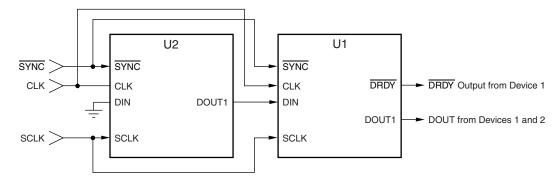
Whether the interface protocol is SPI or Frame-Sync, it is recommended to synchronize all devices by tying the SYNC inputs together. When synchronized in SPI protocol, it is only necessary to monitor the DRDY output of one ADS1278.

In Frame-Sync interface protocol, the data from all devices are ready after the rising edge of FSYNC.

Since DOUT1 and DIN are both shifted on the falling edge of SCLK, the propagation delay on DOUT1 creates a setup time on DIN. Minimize the skew in SCLK to avoid timing violations.



SBAS447E - MARCH 2009-REVISED APRIL 2013



Note: The number of chained devices is limited by the SCLK rate and device mode.

Figure 78. Daisy-Chaining of Two Devices, SPI Protocol (FORMAT[2:0] = 000 or 001)

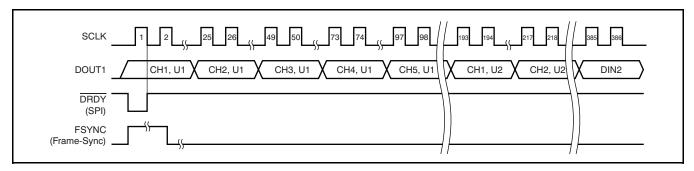
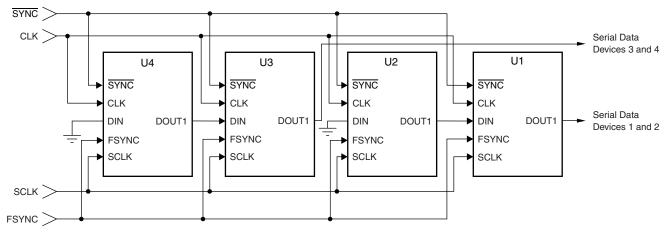


Figure 79. Daisy-Chain Data Format of Figure 78



Note: The number of chained devices is limited by the SCLK rate and device mode.

Figure 80. Segmented DOUT Daisy-Chain, Frame-Sync Protocol (FORMAT[2:0] = 011 or 100)

SBAS447E - MARCH 2009 - REVISED APRIL 2013



www.ti.com

POWER SUPPLIES

The ADS1278 has three power supplies: AVDD, DVDD, and IOVDD. AVDD is the analog supply that powers the modulator, DVDD is the digital supply that powers the digital core, and IOVDD is the digital I/O power supply. The IOVDD and DVDD power supplies can be tied together if desired (1.8 V). To achieve rated performance, it is critical that the power supplies are bypassed with $0.1-\mu$ F and $10-\mu$ F capacitors placed as close as possible to the supply pins. A single $10-\mu$ F ceramic capacitors.

Figure 81 shows the start-up sequence of the ADS1278. At power-on, bring up the DVDD supply first, followed by IOVDD and then AVDD. Check the power-supply sequence for proper order, including the ramp rate of each supply. DVDD and IOVDD may be sequenced at the same time if the supplies are tied together. Each supply has an internal reset circuit whose outputs are summed together to generate a global power-on reset. After the supplies have exceeded the reset thresholds, $2^{18}\ f_{CLK}$ cycles are counted before the converter initiates the conversion process. Following the CLK cycles, the data for 129 conversions are suppressed by the ADS1278 to allow output of fully-settled data. In SPI protocol, DRDY is held high during this interval. In frame-sync protocol, DOUT is forced to zero. The power supplies should be applied before any analog or digital pin is driven. For consistent performance, assert SYNC after device power-on when data first appear.

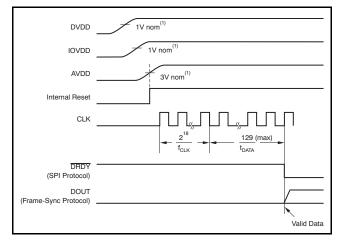


Figure 81. Start-Up Sequence

MODULATOR OUTPUT

The ADS1278 incorporates a 6th-order, single-bit, chopper-stabilized modulator followed by a multistage digital filter that yields the conversion results. The data stream output of the modulator is available directly, bypassing the internal digital filter. The digital filter is disabled, reducing the DVDD current, as shown in Table 18. In this mode, an external digital filter implemented in an ASIC, FPGA, or similar device is required. To invoke the modulator output, tie FORMAT[2:0], as shown in Figure 82. DOUT[8:1] then becomes the modulator data stream outputs for each channel and SCLK becomes the modulator clock output. The DRDY/FSYNC pin becomes an unused output and can be ignored. The normal operation of the Frame-Sync and SPI interfaces is disabled, and the functionality of SCLK changes from an input to an output, as shown in Figure 82.

MODE [1:0]	CLKDIV	MODULATOR CLOCK OUTPUT (SCLK)	DVDD (mA)
00	1	f _{CLK} /4	8
01	1	f _{CLK} /4	7
10	1	f _{CLK} /8	4
10	0	f _{CLK} /4	4
11	1	f _{CLK} /40	1
11	0	f _{CLK} /8	1

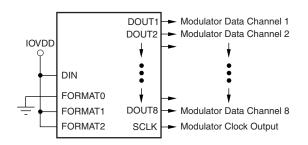


Figure 82. Modulator Output



In modulator output mode, the frequency of the modulator clock output (SCLK) depends on the mode selection of the ADS1278. Table 18 lists the modulator clock output frequency and DVDD current versus device mode.

Figure 83 shows the timing relationship of the modulator clock and data outputs.

The data output is a modulated 1s density data stream. When $V_{IN} = +V_{REF}$, the 1s density is approximately 80% and when $V_{IN} = -V_{REF}$, the 1s density is approximately 20%.

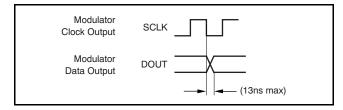


Figure 83. Modulator Output Timing

PIN TEST USING TEST[1:0] INPUTS

The test mode feature of the ADS1278 allows continuity testing of the digital I/O pins. In this mode, the normal functions of the digital pins are disabled and routed to each other as pairs through internal logic, as shown in Table 19. The pins in the left column drive the output pins in the right column. **Note:** some of the digital input pins become outputs; these outputs must be accommodated in the design. The analog input, power supply, and ground pins all remain connected as normal. The test mode is engaged by setting the pins TEST [1:0] = 11. For normal converter operation, set TEST[1:0] = 00. Do not use '01' or '10'.

SBAS447E - MARCH 2009-REVISED APRIL 2013

Table 19. Test Mode Pin Map (TEST[1:0] =
--

TEST MODE PIN MAP									
INPUT PINS	OUTPUT PINS								
PWDN1	DOUT1								
PWDN2	DOUT2								
PWDN3	DOUT3								
PWDN4	DOUT4								
PWDN5	DOUT5								
PWDN6	DOUT6								
PWDN7	DOUT7								
PWDN8	DOUT8								
MODE0	DIN								
MODE1	SYNC								
FORMAT0	CLKDIV								
FORMAT1	FSYNC/DRDY								
FORMAT2	SCLK								

VCOM OUTPUT

The VCOM pin provides a voltage output equal to AVDD/2. The intended use of this output is to set the output common-mode level of the analog input drivers. The drive capability of the output is limited; therefore, the output should only be used to drive high-impedance nodes (> 1 M Ω). In some cases, an external buffer may be necessary. A 0.1-µF bypass capacitor is recommended to reduce noise pickup.

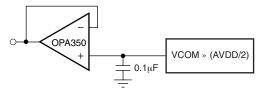


Figure 84. VCOM Output

ADS1278-HT

SBAS447E - MARCH 2009-REVISED APRIL 2013

48

APPLICATION INFORMATION

To obtain the specified performance from the ADS1278, the following layout and component guidelines should be considered.

- 1. Power Supplies: The device requires three power supplies for operation: DVDD, IOVDD, and AVDD. The allowed range for DVDD is 1.65 V to 1.95 V; the range of IOVDD is 1.65 V to 3.6 V; AVDD is restricted to 4.75 V to 5.25 V. For all supplies, use a 10-µF tantalum capacitor, bypassed with a 0.1-µF ceramic capacitor, placed close to the device pins. Alternatively, a single 10-µF ceramic capacitor can be used. The supplies should be relatively free of noise and should not be shared with devices that produce voltage spikes (such as relays, LED display drivers, etc.). If a switching power-supply source is used, the voltage ripple should be low (less than 2 mV) and the switching frequency outside the passband of the converter.
- 2. **Ground Plane:** A single ground plane connecting both AGND and DGND pins can be used. If separate digital and analog grounds are used, connect the grounds together at the converter.
- 3. **Digital Inputs:** It is recommended to sourceterminate the digital inputs to the device with 50- Ω series resistors. The resistors should be placed close to the driving end of digital source (oscillator, logic gates, DSP, etc.) This placement helps to reduce ringing on the digital lines (ringing may lead to degraded ADC performance).
- 4. Analog/Digital Circuits: Place analog circuitry (input buffer, reference) and associated tracks together, keeping them away from digital circuitry (DSP, microcontroller, logic). Avoid crossing digital tracks across analog tracks to reduce noise coupling and crosstalk.
- 5. **Reference Inputs:** It is recommended to use a minimum 10- μ F tantalum with a 0.1- μ F ceramic capacitor directly across the reference inputs, VREFP and VREFN. The reference input should be driven by a low-impedance source. For best performance, the reference should have less than 3 μ V_{RMS} in-band noise. For references with noise higher than this level, external reference filtering may be necessary.

- 6. Analog Inputs: The analog input pins must be differentially driven to achieve specified performance. A true differential driver or transformer (ac applications) can be used for this purpose. Route the analog inputs tracks (AINP, AINN) as a pair from the buffer to the converter using short, direct tracks and away from digital tracks. A 1-nF to 10-nF capacitor should be used directly across the analog input pins, AINP and AINN. A low-k dielectric (such as COG or film type) should be used to maintain low THD. Capacitors from each analog input to ground can be used. They should be no larger than 1/10 the size of the difference capacitor (typically 100 pF) to preserve the ac common-mode performance.
- 7. **Component Placement:** Place the power supply, analog input, and reference input bypass capacitors as close as possible to the device pins. This layout is particularly important for small-value ceramic capacitors. Larger (bulk) decoupling capacitors can be located farther from the device than the smaller ceramic capacitors.



www.ti.com



PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	Package	Eco Plan	Lead finish/	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	Ball material	(3)		(4/5)	
							(6)				
ADS1278HPAP	ACTIVE	HTQFP	PAP	64	160	RoHS & Green	NIPDAU	Level-4-260C-72 HR	-55 to 175	ADS1278	Samples
ADS1278SHFQ	ACTIVE	CFP	HFQ	84	10	RoHS & Green	Call TI	Call TI	-55 to 210	ADS1278 SHFQ	Samples
ADS1278SHKP	ACTIVE	CFP	НКР	84	1	RoHS & Green	Call TI	Call TI	-55 to 210	ADS1278 SHKP	Samples
ADS1278SKGDA	ACTIVE	XCEPT	KGD	0	36	RoHS & Green	Call TI	N / A for Pkg Type	-55 to 210		Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and



continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF ADS1278-HT :

- Catalog : ADS1278
- Enhanced Product : ADS1278-EP
- Space : ADS1278-SP

NOTE: Qualified Version Definitions:

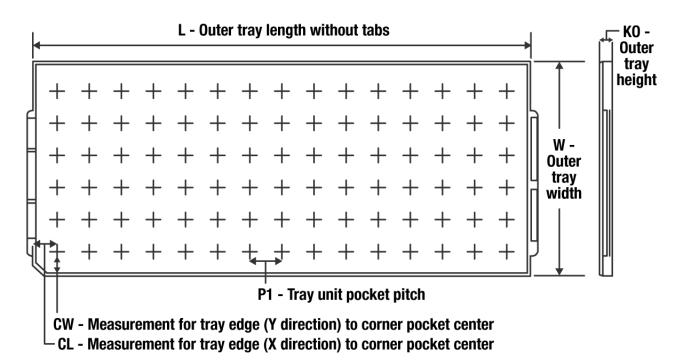
- Catalog TI's standard catalog product
- Enhanced Product Supports Defense, Aerospace and Medical Applications
- Space Radiation tolerant, ceramic packaging and qualified for use in Space-based application

Texas Instruments

www.ti.com

TRAY

5-Jan-2022



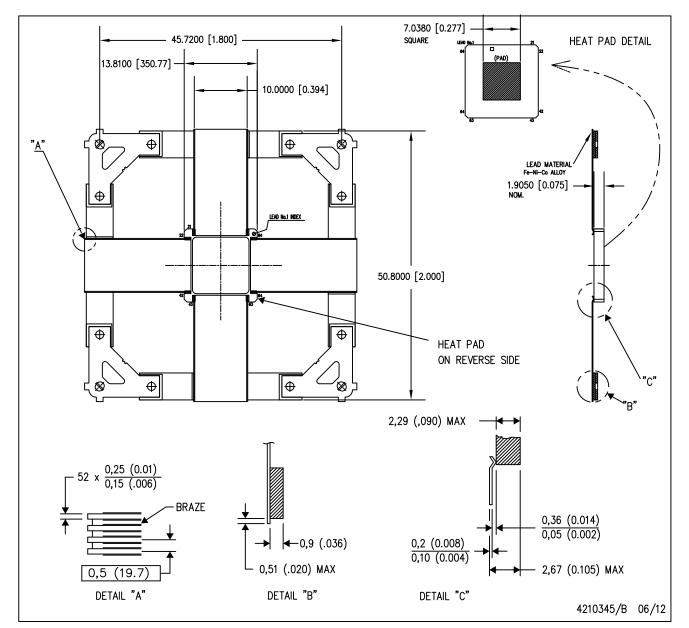
Chamfer on Tray corner indicates Pin 1 orientation of packed units.

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	Unit array matrix	Max temperature (°C)	L (mm)	W (mm)	K0 (µm)	P1 (mm)	CL (mm)	CW (mm)
ADS1278HPAP	PAP	HTQFP	64	160	8 x 20	150	315	135.9	7620	15.2	13.1	13

HFQ (S-CQFP-F84)

CERAMIC QUAD FLATPACK WITH NCTB



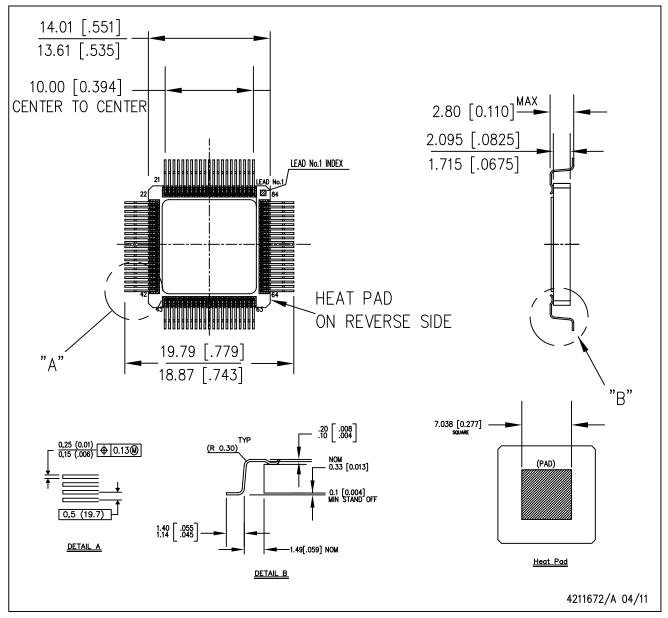
NOTES: A. All linear dimensions are in millimeters (inches).

- B. This drawing is subject to change without notice.
- C. Ceramic quad flatpack with flat leads brazed to non-conductive tie bar carrier.
- D. This package is hermetically sealed with a metal lid.
- E. The leads are gold plated and can be solderdipped.
- F. Leads not shown for clarity purposes.
- G. Lid and heat sink are connected to GND leads.



HKP (S-CQFP-G84)

CERAMIC QUAD FLATPACK - GULL WING



- NOTES: A. All linear dimensions are in millimeters (inches).
 - B. This drawing is subject to change without notice.
 - C. Ceramic quad flatpack with formed leads.
 - D. This package is hermetically sealed with a metal lid.
 - E. The leads are gold plated and can be solderdipped.
 - F. Lid and heat pad are electrically connected.



PAP 64

10 x 10, 0.5 mm pitch

GENERIC PACKAGE VIEW

HTQFP - 1.2 mm max height

QUAD FLATPACK

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



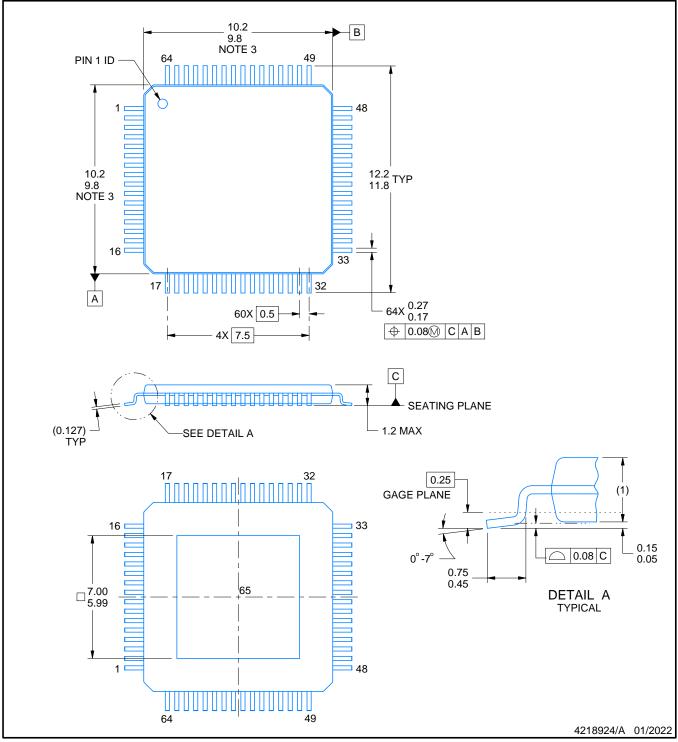


PAP0064G

PACKAGE OUTLINE

PowerPAD[™] TQFP - 1.2 mm max height

PLASTIC QUAD FLATPACK



NOTES:

PowerPAD is a trademark of Texas Instruments.

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs.
- 4. Strap features may not be present.
- 5. Reference JEDEC registration MS-026.

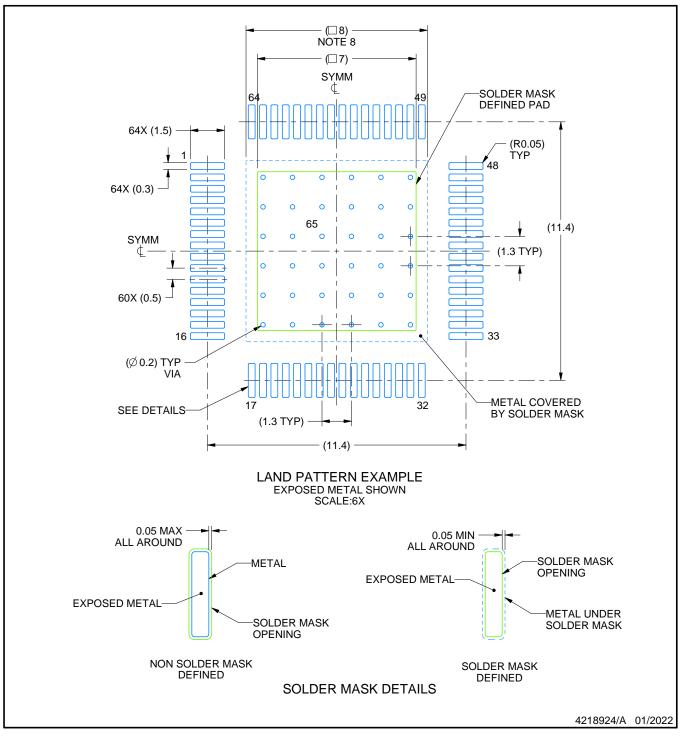


PAP0064G

EXAMPLE BOARD LAYOUT

PowerPAD[™] TQFP - 1.2 mm max height

PLASTIC QUAD FLATPACK



NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- This package is designed to be soldered to a thermal pad on the board. See technical brief, Powerpad thermally enhanced package, Texas Instruments Literature No. SLMA002 (www.ti.com/lit/slma002) and SLMA004 (www.ti.com/lit/slma004).
- Vias are optional depending on application, refer to device data sheet. It is recommended that vias under paste be filled, plugged or tented.
- 10. Size of metal pad may vary due to creepage requirement.

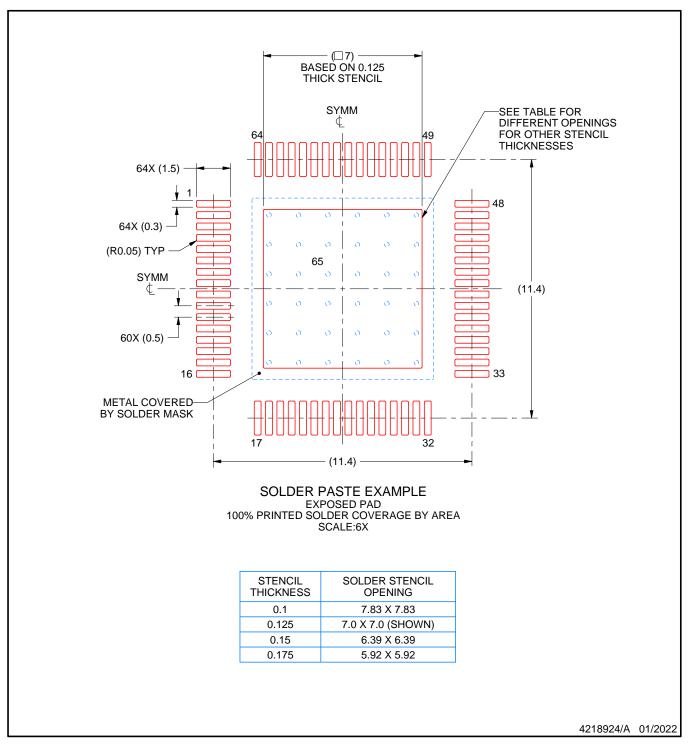


PAP0064G

EXAMPLE STENCIL DESIGN

PowerPAD[™] TQFP - 1.2 mm max height

PLASTIC QUAD FLATPACK



NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

12. Board assembly site may have different recommendations for stencil design.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2024, Texas Instruments Incorporated